



VND5E050ACJ-E VND5E050ACK-E

Double channel high-side driver with analog current sense
for automotive applications

Features

Max transient supply voltage	V_{CC}	41 V
Operating voltage range	V_{CC}	4.5 to 28 V
Max On-state resistance (per ch.)	R_{ON}	50 m Ω
Current limitation (typ)	I_{LIMH}	27 A
Off-state supply current	I_S	2 μ A ⁽¹⁾

1. Typical value with all loads connected.

- General
 - Inrush current active management by power limitation
 - Very low standby current
 - 3.0 V CMOS compatible inputs
 - Optimized electromagnetic emissions
 - Very low electromagnetic susceptibility
 - Compliance with European directive 2002/95/EC
 - Very low current sense leakage
- Diagnostic functions
 - Proportional load current sense
 - High current sense precision for wide currents range
 - Current sense disable
 - Off-state open load detection
 - Output short to V_{CC} detection
 - Overload and short to ground (power limitation) indication
 - Thermal shutdown indication
- Protections
 - Undervoltage shutdown
 - Overvoltage clamp
 - Load current limitation
 - Self limiting of fast thermal transients
 - Protection against loss of ground and loss of V_{CC}
 - Overtemperature shutdown with auto restart (thermal shutdown)



- Reverse battery protected
- Electrostatic discharge protection

Applications

- All types of resistive, inductive and capacitive loads
- Suitable as LED driver

Description

The VND5E050ACJ-E and VND5E050ACK-E are double channel high-side drivers manufactured using ST proprietary VIPower® M0-5 technology and housed in PowerSSO-12 and PowerSSO-24 packages. The devices are designed to drive 12 V automotive grounded loads, and to provide protection and diagnostics. They also implement a 3 V and 5 V CMOS-compatible interface for use with any microcontroller.

The devices integrate advanced protective functions such as load current limitation, inrush and overload active management by power limitation, overtemperature shut-off with auto-restart and overvoltage active clamp. A dedicated analog current sense pin is associated with every output channel providing enhanced diagnostic functions including fast detection of overload and short-circuit to ground through power limitation indication, overtemperature indication, short-circuit to V_{CC} diagnosis on-state and off-state open-load detection.

The current sensing and diagnostic feedback of the whole device can be disabled by pulling the CS_DIS pin high to share the external sense resistor with similar devices.

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1 Block diagram and pin description

Figure 1. Block diagram

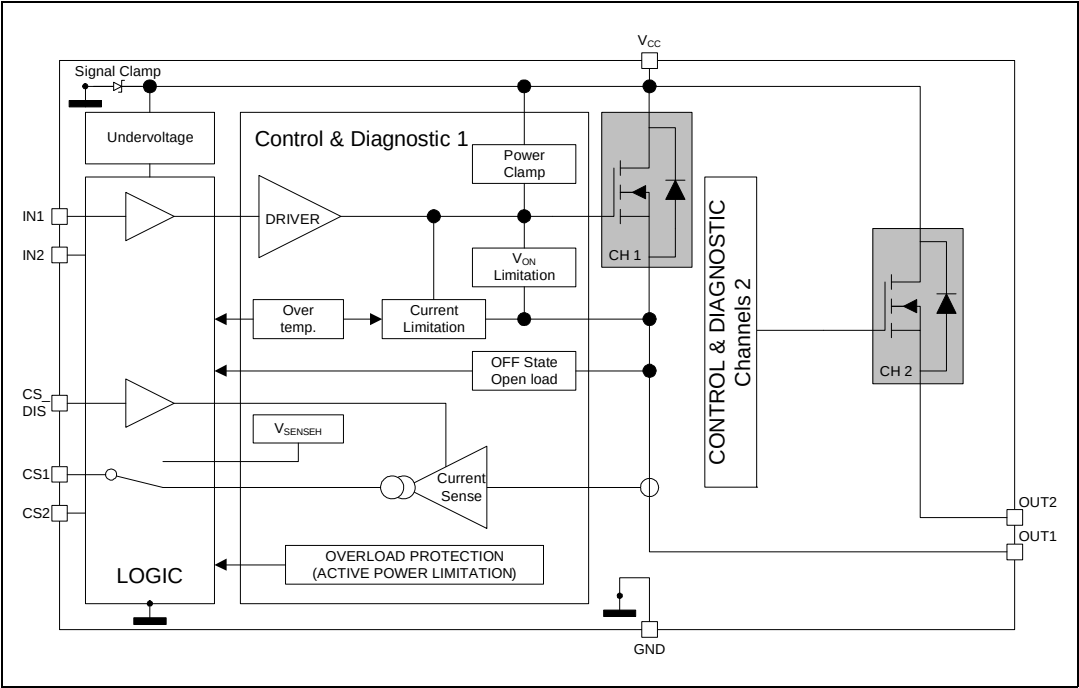


Table 1. Pin function

Name	Function
V _{CC}	Battery connection.
OUTPUT _{1,2}	Power output.
GND	Ground connection. Must be reverse battery protected by an external diode/resistor network.
INPUT _{1,2}	Voltage controlled input pin with hysteresis, CMOS compatible. Controls output switch state.
CURRENT SENSE _{1,2}	Analog current sense pin, delivers a current proportional to the load current.
CS_DIS	Active high CMOS compatible pin, to disable the current sense pin.

Figure 2. Configuration diagram (top view)

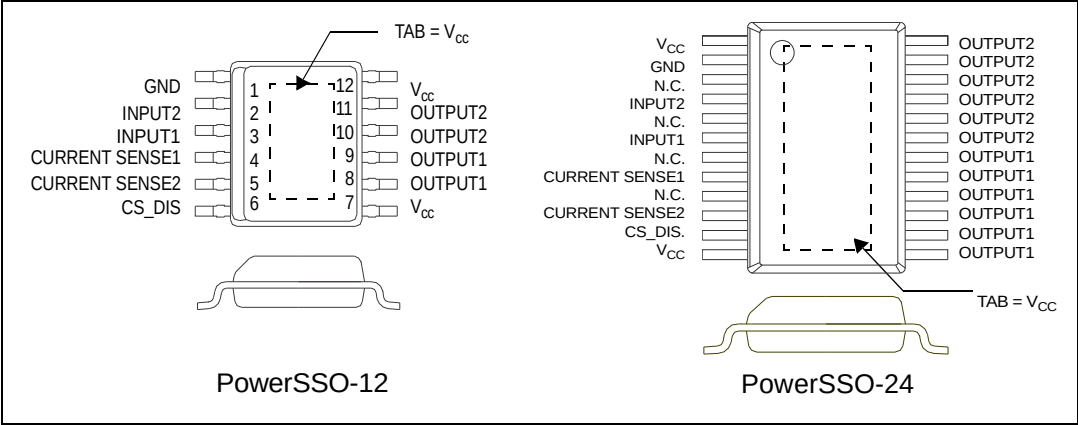
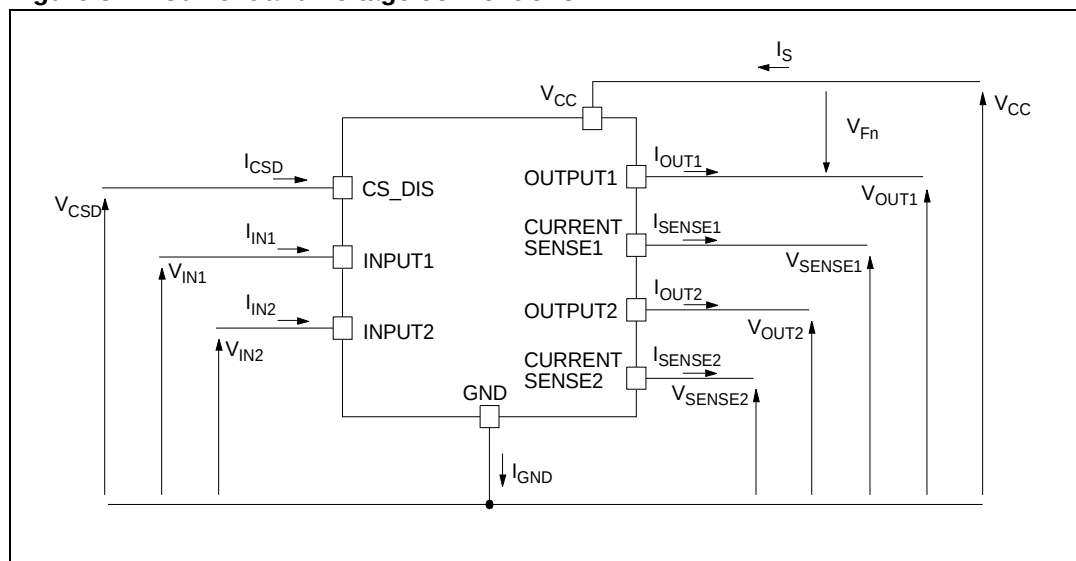


Table 2. Suggested connections for unused and not connected pins

Connection / pin	Current sense	N.C.	Output	Input	CS_DIS
Floating	Not allowed	X	X	X	X
To ground	Through 1 KΩ resistor	X	Through 22 KΩ resistor	Through 10 KΩ resistor	Through 10 KΩ resistor

2 Electrical specifications

Figure 3. Current and voltage conventions



Note: $V_{Fn} = V_{OUTn} - V_{CC}$ during reverse battery condition.

2.1 Absolute maximum ratings

Stressing the device above the rating listed in the “Absolute maximum ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to the conditions in the table for extended periods may affect device reliability.

Table 3. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	DC supply voltage	41	V
$-V_{CC}$	Reverse DC supply voltage	0.3	V
$-I_{GND}$	DC reverse ground pin current	200	mA
I_{OUT}	DC output current	Internally limited	A
$-I_{OUT}$	Reverse DC output current	20	A
I_{IN}	DC input current	-1 to 10	mA
I_{CSD}	DC current sense disable input current	-1 to 10	mA
$-I_{CSENSE}$	DC reverse CS pin current	200	mA
V_{CSENSE}	Current sense maximum voltage	$V_{CC} - 41$ to $+V_{CC}$	V

Table 3. Absolute maximum ratings (continued)

Symbol	Parameter	Value	Unit
E_{MAX}	Maximum switching energy (single pulse) ($L = 3\text{mH}$; $R_L = 0\Omega$; $V_{bat} = 13.5\text{V}$; $T_{jstart} = 150^\circ\text{C}$; I_{OUT})	104	mJ
V_{ESD}	Electrostatic discharge (human body model: $R = 1.5\text{K}\Omega$; $C = 100\text{pF}$)		
	– Input	4000	V
	– Current sense	2000	V
	– CS_DIS	4000	V
	– Output	5000	V
	– V_{CC}	5000	V
V_{ESD}	Charge device model (CDM-AEC-Q100-011)	750	V
T_j	Junction operating temperature	-40 to 150	$^\circ\text{C}$
T_{stg}	Storage temperature	-55 to 150	$^\circ\text{C}$

2.2 Thermal data

Table 4. Thermal data

Symbol	Parameter	Max value		Unit
		PowerSSO-12	PowerSSO-24	
$R_{thj-case}$	Thermal resistance junction-case (with one channel ON)	2.7	2.7	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient	See Figure 36	See Figure 40	$^\circ\text{C/W}$

2.3 Electrical characteristics

Values specified in this section are for $8\text{ V} < V_{CC} < 28\text{ V}$; $-40\text{ }^\circ\text{C} < T_j < 150\text{ }^\circ\text{C}$, unless otherwise stated.

Table 5. Power section

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{CC}	Operating supply voltage		4.5	13	28	V
V_{USD}	Undervoltage shutdown			3.5	4.5	V
$V_{USDhyst}$	Undervoltage shutdown hysteresis			0.5		V
R_{ON}	On-state resistance ⁽¹⁾	$I_{OUT} = 2\text{ A}$; $T_j = 25^\circ\text{C}$			50	m Ω
		$I_{OUT} = 2\text{ A}$; $T_j = 150^\circ\text{C}$			100	
		$I_{OUT} = 2\text{ A}$; $V_{CC} = 5\text{ V}$; $T_j = 25^\circ\text{C}$			65	
V_{clamp}	Clamp voltage	$I_S = 20\text{ mA}$	41	46	52	V

Table 5. Power section (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_S	Supply current	Off-state; $V_{CC} = 13\text{ V}$; $T_j = 25^\circ\text{C}$; $V_{IN} = V_{OUT} = V_{SENSE} = V_{CSD} = 0\text{ V}$		2 ⁽²⁾	5 ⁽²⁾	μA
		On-state; $V_{CC} = 13\text{ V}$; $V_{IN} = 5\text{ V}$; $I_{OUT} = 0\text{ A}$		3	6	mA
$I_{L(off1)}$	Off-state output current (1)	$V_{IN} = V_{OUT} = 0\text{ V}$; $V_{CC} = 13\text{ V}$; $T_j = 25^\circ\text{C}$	0	0.01	3	μA
		$V_{IN} = V_{OUT} = 0\text{ V}$; $V_{CC} = 13\text{ V}$; $T_j = 125^\circ\text{C}$	0		5	
V_F	Output - V_{CC} diode voltage ⁽¹⁾	$-I_{OUT} = 4\text{ A}$; $T_j = 150^\circ\text{C}$			0.7	V

1. For each channel.

2. PowerMOS leakage included.

Table 6. Switching ($V_{CC} = 13\text{V}$; $T_j = 25^\circ\text{C}$)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$R_L = 6.5\Omega$ (see Figure 6)	—	20	—	μs
$t_{d(off)}$	Turn-off delay time	$R_L = 6.5\Omega$ (see Figure 6)	—	45	—	μs
$dV_{OUT}/dt_{(on)}$	Turn-on voltage slope	$R_L = 6.5\Omega$	—	See Figure 26	—	$\text{V}/\mu\text{s}$
$dV_{OUT}/dt_{(off)}$	Turn-off voltage slope	$R_L = 6.5\Omega$	—	See Figure 28	—	$\text{V}/\mu\text{s}$
W_{ON}	Switching energy losses during t_{won}	$R_L = 6.5\Omega$ (see Figure 6)	—	0.15	—	mJ
W_{OFF}	Switching energy losses during t_{woff}	$R_L = 6.5\Omega$ (see Figure 6)	—	0.3	—	mJ

Table 7. Logic inputs

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{IL}	Input low level voltage				0.9	V
I_{IL}	Low level input current	$V_{IN} = 0.9\text{ V}$	1			μA
V_{IH}	Input high level voltage		2.1			V
I_{IH}	High level input current	$V_{IN} = 2.1\text{ V}$			10	μA
$V_{I(hyst)}$	Input hysteresis voltage		0.25			V
V_{ICL}	Input clamp voltage	$I_{IN} = 1\text{ mA}$	5.5		7	V
		$I_{IN} = -1\text{ mA}$		-0.7		
V_{CSDL}	CS_DIS low level voltage				0.9	V
I_{CSDL}	Low level CS_DIS current	$V_{CSD} = 0.9\text{ V}$	1			μA
V_{CSDH}	CS_DIS high level voltage		2.1			V

Table 7. Logic inputs (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{CSDH}	High level CS_DIS current	$V_{CSD} = 2.1\text{ V}$			10	μA
$V_{CSD(hyst)}$	CS_DIS hysteresis voltage		0.25			V
V_{CSCL}	CS_DIS clamp voltage	$I_{CSD} = 1\text{ mA}$	5.5		7	V
		$I_{CSD} = -1\text{ mA}$		-0.7		

Table 8. Protections and diagnostics ⁽¹⁾

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{limH}	DC short circuit current	$V_{CC} = 13\text{ V}$	19	27	38	A
		$5\text{ V} < V_{CC} < 28\text{ V}$			38	A
I_{limL}	Short circuit current during thermal cycling	$V_{CC} = 13\text{ V};$ $T_R < T_j < T_{TSD}$		7		A
T_{TSD}	Shutdown temperature		150	175	200	$^{\circ}\text{C}$
T_R	Reset temperature		$T_{RS}+1$	$T_{RS}+5$		$^{\circ}\text{C}$
T_{RS}	Thermal reset of status		135			$^{\circ}\text{C}$
T_{HYST}	Thermal hysteresis ($T_{TSD} - T_R$)			7		$^{\circ}\text{C}$
V_{DEMAG}	Turn-off output voltage clamp	$I_{OUT} = 2\text{ A}; V_{IN} = 0;$ $L = 6\text{ mH}$	$V_{CC}-41$	$V_{CC}-46$	$V_{CC}-52$	V
V_{ON}	Output voltage drop limitation	$I_{OUT} = 0.1\text{ A};$ $T_j = -40^{\circ}\text{C} \dots +150^{\circ}\text{C}$ (see Figure 8)		25		mV

1. To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles.

Table 9. Current sense ($8\text{ V} < V_{CC} < 18\text{ V}$)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
K_0	I_{OUT}/I_{SENSE}	$I_{OUT} = 0.05\text{ A};$ $V_{SENSE} = 0.5\text{ V}; V_{CSD} = 0\text{ V};$ $T_j = -40^{\circ}\text{C} \dots 150^{\circ}\text{C}$	1440	2250	3630	
K_1	I_{OUT}/I_{SENSE}	$I_{OUT} = 1\text{ A}; V_{SENSE} = 4\text{ V}; V_{CSD} = 0\text{ V};$ $T_j = -40^{\circ}\text{C} \dots 150^{\circ}\text{C}$	1740	2070	2820	
		$T_j = 25^{\circ}\text{C} \dots 150^{\circ}\text{C}$	1750	2070	2562	
$dK_1/K_1^{(1)}$	Current sense ratio drift	$I_{OUT} = 1\text{ A}; V_{SENSE} = 4\text{ V}; V_{CSD} = 0\text{ V};$ $T_j = -40^{\circ}\text{C} \text{ to } 150^{\circ}\text{C}$	-15		15	%
K_2	I_{OUT}/I_{SENSE}	$I_{OUT} = 2\text{ A}; V_{SENSE} = 4\text{ V}; V_{CSD} = 0\text{ V};$ $T_j = -40^{\circ}\text{C} \dots 150^{\circ}\text{C}$	1900	2000	2395	
		$T_j = 25^{\circ}\text{C} \dots 150^{\circ}\text{C}$	1899	2000	2282	
$dK_2/K_2^{(1)}$	Current sense ratio drift	$I_{OUT} = 2\text{ A}; V_{SENSE} = 4\text{ V}; V_{CSD} = 0\text{ V};$ $T_j = -40^{\circ}\text{C} \text{ to } 150^{\circ}\text{C}$	-9		9	%

Table 9. Current sense (8 V < V_{CC} < 18 V) (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
K ₃	I _{OUT} /I _{SENSE}	I _{OUT} = 4 A; V _{SENSE} = 4 V; V _{CSD} = 0 V; T _j = -40°C...150°C T _j = 25°C...150°C	1969 1950	1990 1990	2210 2153	
dK ₃ /K ₃ ⁽¹⁾	Current sense ratio drift	I _{OUT} = 4 A; V _{SENSE} = 4 V; V _{CSD} = 0 V; T _j = -40 °C to 150 °C	-6		6	%
I _{SENSE0}	Analog sense leakage current	I _{OUT} = 0 A; V _{SENSE} = 0 V; V _{CSD} = 5 V; V _{IN} = 0 V; T _j = -40°C...150°C	0		1	μA
		I _{OUT} = 0 A; V _{SENSE} = 0 V; V _{CSD} = 0 V; V _{IN} = 5 V; T _j = -40°C...150°C	0		2	
		I _{OUT} = 2 A; V _{SENSE} = 0 V; V _{CSD} = 5 V; V _{IN} = 5 V; T _j = -40°C...150°C	0		1	
I _{OL}	Open load on-state current detection threshold	V _{IN} = 5 V; 8 V < V _{CC} < 18 V; I _{SENSE} = 5 μA	4		20	mA
V _{SENSE}	Max analog sense output voltage	I _{OUT} = 4 A; V _{CSD} = 0 V	5			V
V _{SENSEH}	Analog sense output voltage in fault condition ⁽²⁾	V _{CC} = 13 V; R _{SENSE} = 3.9 KΩ		8		V
I _{SENSEH}	Analog sense output current in fault condition ⁽²⁾	V _{CC} = 13 V; V _{SENSE} = 5 V		9		mA
t _{DSENSE1H}	Delay response time from falling edge of CS_DIS pin	V _{SENSE} < 4 V; 0.5 A < I _{OUT} < 4 A; I _{SENSE} = 90% of I _{SENSEMAX} (see Figure 4)		40	100	μs
t _{DSENSE1L}	Delay response time from rising edge of CS_DIS pin	V _{SENSE} < 4 V; 0.5 A < I _{OUT} < 4 A; I _{SENSE} = 10% of I _{SENSEMAX} (see Figure 4)		5	20	μs
t _{DSENSE2H}	Delay response time from rising edge of INPUT pin	V _{SENSE} < 4 V; 0.5 A < I _{OUT} < 4 A; I _{SENSE} = 90% of I _{SENSEMAX} (see Figure 4)		80	250	μs
Δt _{DSENSE2H}	Delay response time between rising edge of output current and rising edge of current sense	V _{SENSE} < 4V; I _{SENSE} = 90% of I _{SENSEMAX} , I _{OUT} = 90% of I _{OUTMAX} I _{OUTMAX} = 2A (see Figure 7)			40	μs
t _{DSENSE2L}	Delay response time from falling edge of INPUT pin	V _{SENSE} < 4 V; 0.5 A < I _{OUT} < 4 A; I _{SENSE} = 10% of I _{SENSEMAX} (see Figure 4)		80	250	μs

1. Parameter guaranteed by design; it is not tested.

2. Fault condition includes: power limitation, over temperature and open load off-state detection.

Table 10. Open load detection ($8V < V_{CC} < 18V$)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{OL}	Open load off-state voltage detection threshold	$V_{IN} = 0\text{ V}$	2	See Figure 5	4	V
t_{DSTKON}	Output short circuit to V_{CC} detection delay at turn-off	See Figure 5	180		1200	μs
$I_{L(off2)r}$	Off-state output current at $V_{OUT} = 4\text{ V}$	$V_{IN} = 0\text{ V}$; $V_{SENSE} = 0\text{ V}$; V_{OUT} rising from 0 V to 4 V	-120		0	μA
$I_{L(off2)f}$	Off-state output current at $V_{OUT} = 2\text{ V}$	$V_{IN} = 0\text{ V}$; $V_{SENSE} = V_{SENSEH}$; V_{OUT} falling from V_{CC} to 2 V	-50		90	μA
td_vol	Delay response from output rising edge to V_{SENSE} rising edge in open load	$V_{OUT} = 4\text{ V}$; $V_{IN} = 0\text{ V}$; $V_{SENSE} = 90\%$ of V_{SENSEH}			20	μs

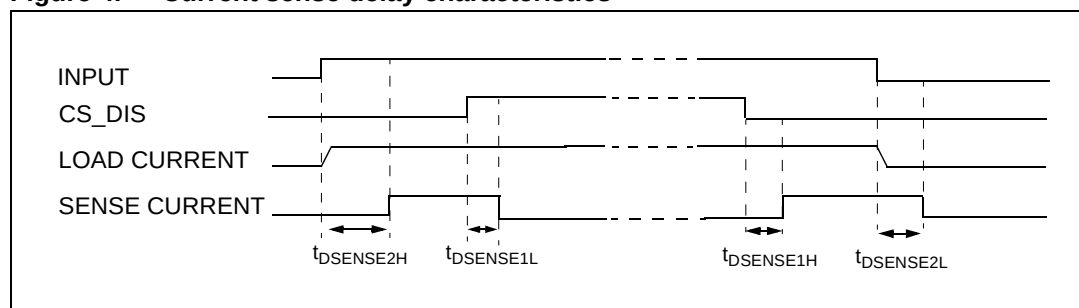
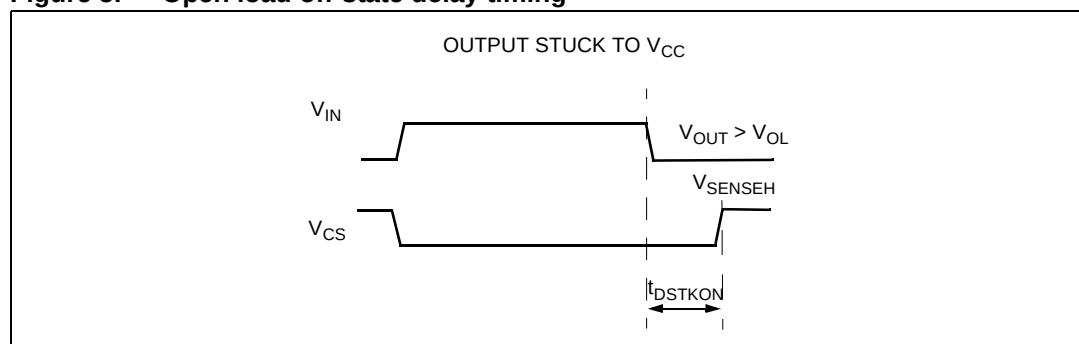
Figure 4. Current sense delay characteristics**Figure 5. Open load off-state delay timing**

Figure 6. Switching characteristics

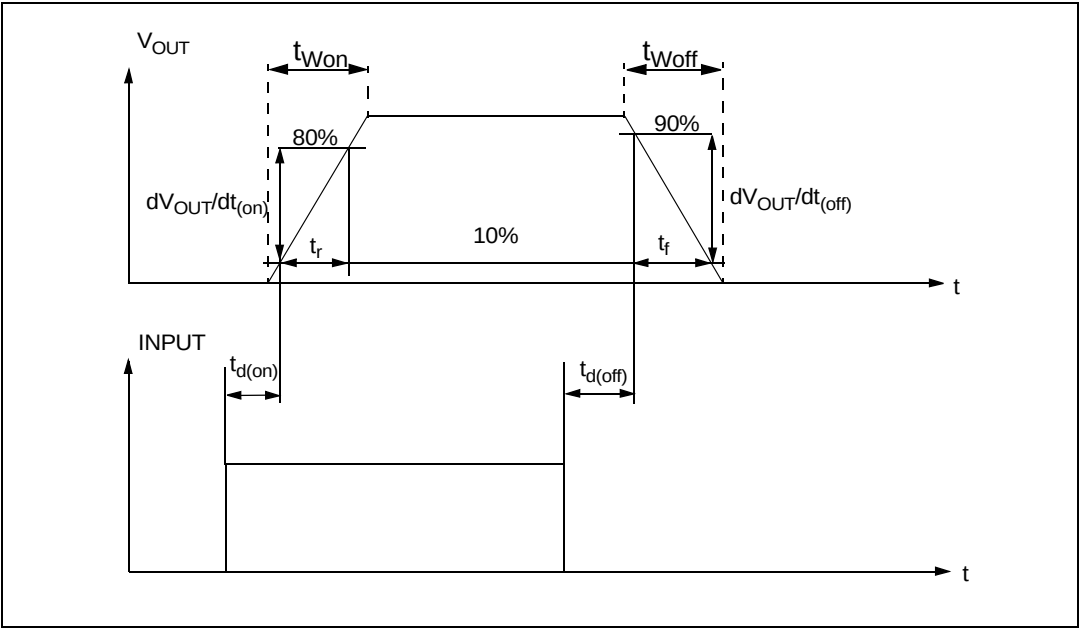


Figure 7. Delay response time between rising edge of output current and rising edge of current sense (CS enabled)

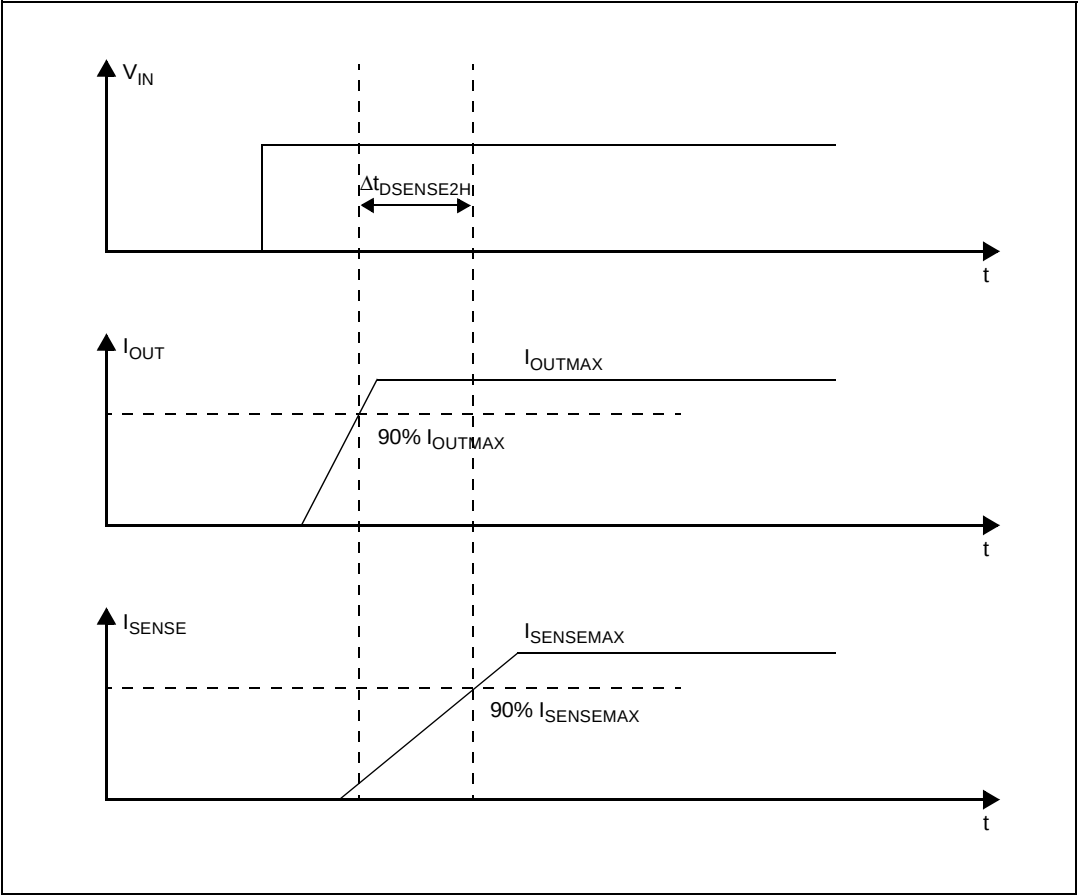


Figure 8. Output voltage drop limitation

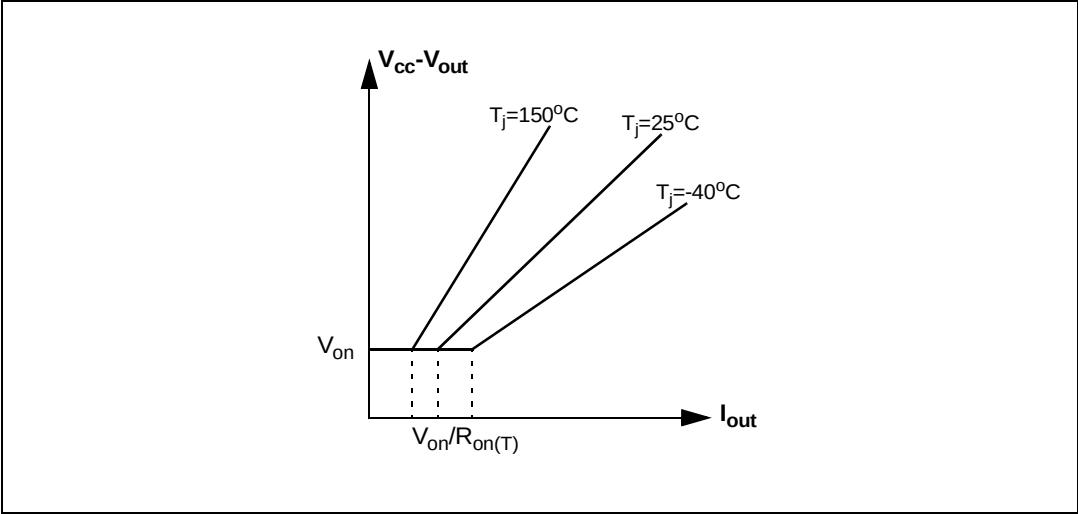


Figure 9. I_{OUT}/I_{SENSE} vs I_{OUT}

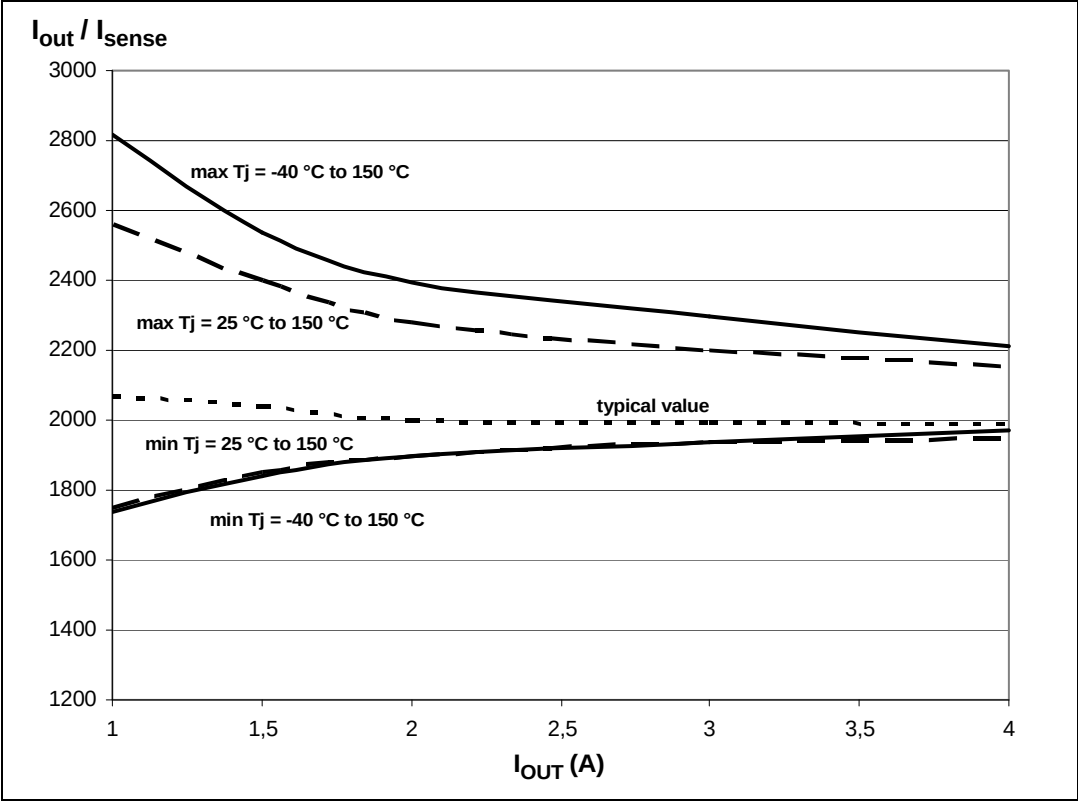
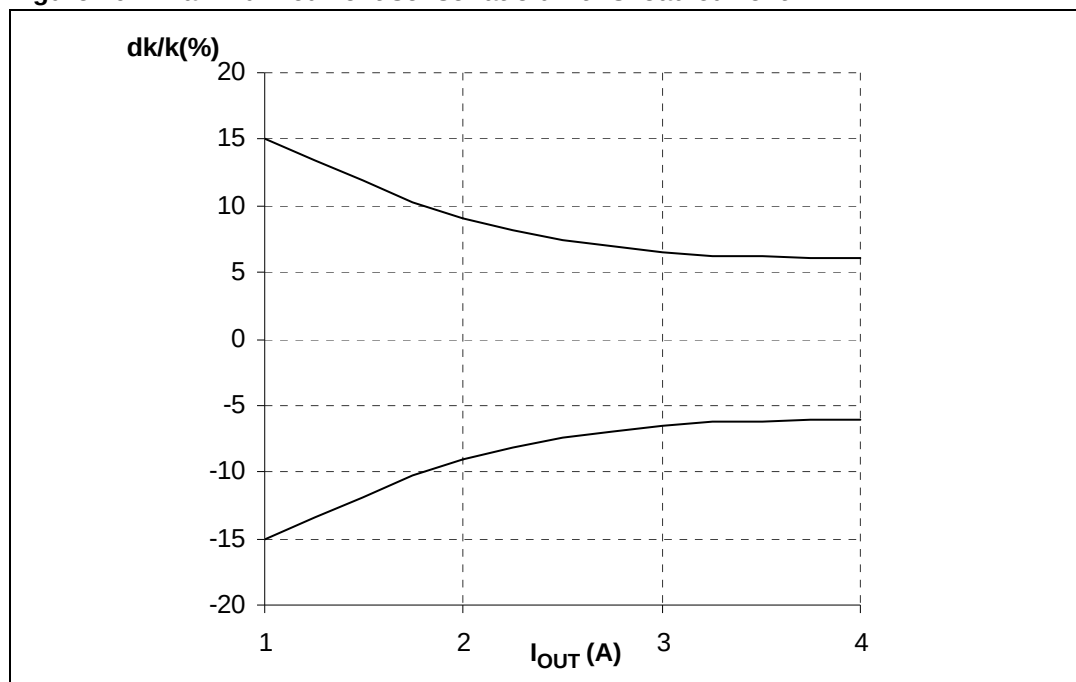


Figure 10. Maximum current sense ratio drift vs load current



Note: Parameter guaranteed by design; it is not tested.

Table 11. Truth table

Conditions	Input	Output	Sense ($V_{CSD} = 0\text{ V}$) ⁽¹⁾
Normal operation	L H	L H	0 Nominal
Overtemperature	L H	L L	0 V_{SENSEH}
Undervoltage	L H	L L	0 0
Overload	H H	X (no power limitation) Cycling (power limitation)	Nominal V_{SENSEH}
Short circuit to GND (power limitation)	L H	L L	0 V_{SENSEH}
Open load off-state (with external pull-up)	L	H	V_{SENSEH}
Short circuit to V_{CC} (external pull-up disconnected)	L H	H H	V_{SENSEH} < Nominal
Negative output voltage clamp	L	L	0

1. If the V_{CSD} is high, the SENSE output is at high impedance; its potential depends on leakage currents and external circuits.

Table 12. Electrical transient requirements (part 1)

ISO 7637-2: 2004(E) test pulse	Test levels ⁽¹⁾		Number of pulses or test times	Burst cycle/pulse repetition time		Delays and Impedance
	III	IV		Min.	Max.	
1	-75V	-100V	5000 pulses	0.5s	5s	2 ms, 10Ω
2a	+37V	+50V	5000 pulses	0.2s	5s	50μs, 2Ω
3a	-100V	-150V	1h	90ms	100ms	0.1μs, 50Ω
3b	+75V	+100V	1h	90ms	100ms	0.1μs, 50Ω
4	-6V	-7V	1 pulse			100ms, 0.01Ω
5b ⁽²⁾	+65V	+87V	1 pulse			400ms, 2Ω

1. The above test levels must be considered referred to $V_{CC} = 13.5V$ except for pulse 5b.

2. Valid in case of external load dump clamp: 40V maximum referred to ground.

Table 13. Electrical transient requirements (part 2)

ISO 7637-2: 2004E test pulse	Test level results	
	III	VI
1	C	C
2a	C	C
3a	C	C
3b	C	C
4	C	C
5b ⁽¹⁾	C	C

1. Valid in case of external load dump clamp: 40V maximum referred to ground.

Table 14. Electrical transient requirements (part 3)

Class	Contents
C	All functions of the device performed as designed after exposure to disturbance.
E	One or more functions of the device did not perform as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

2.4 Waveforms

Figure 11. Normal operation

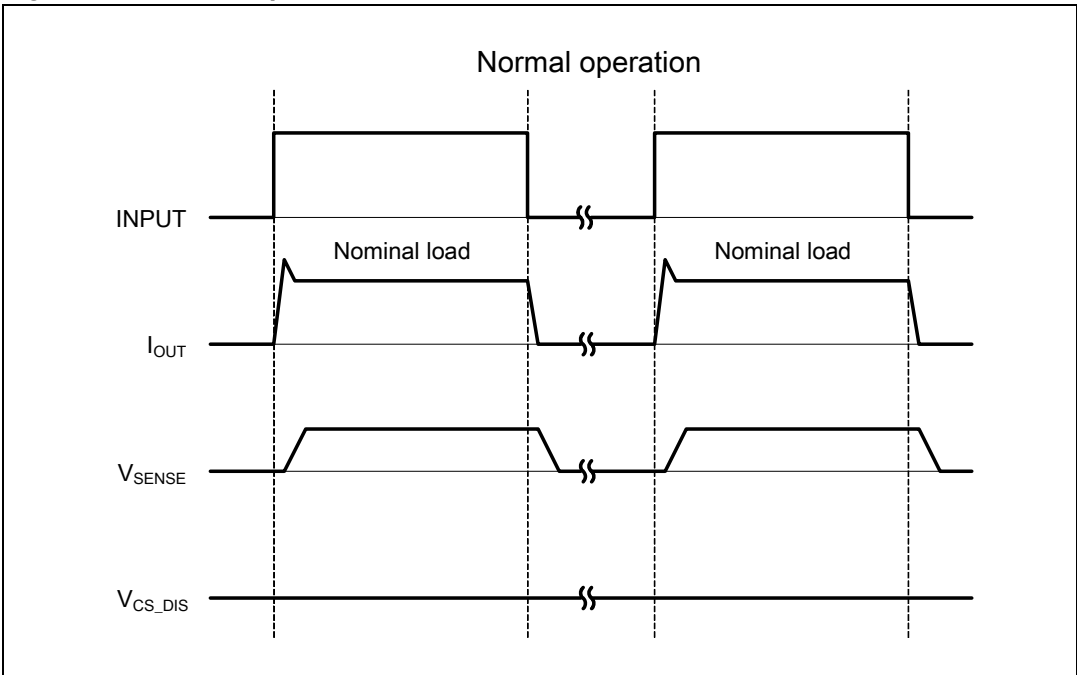


Figure 12. Overload or short to GND

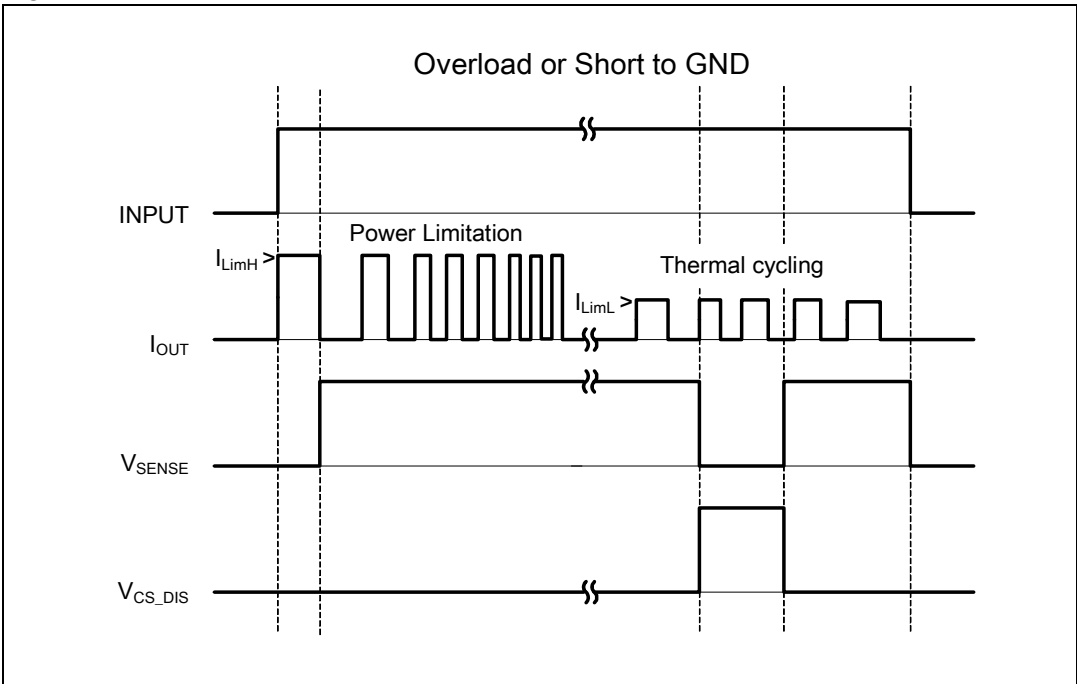


Figure 13. Intermittent overload

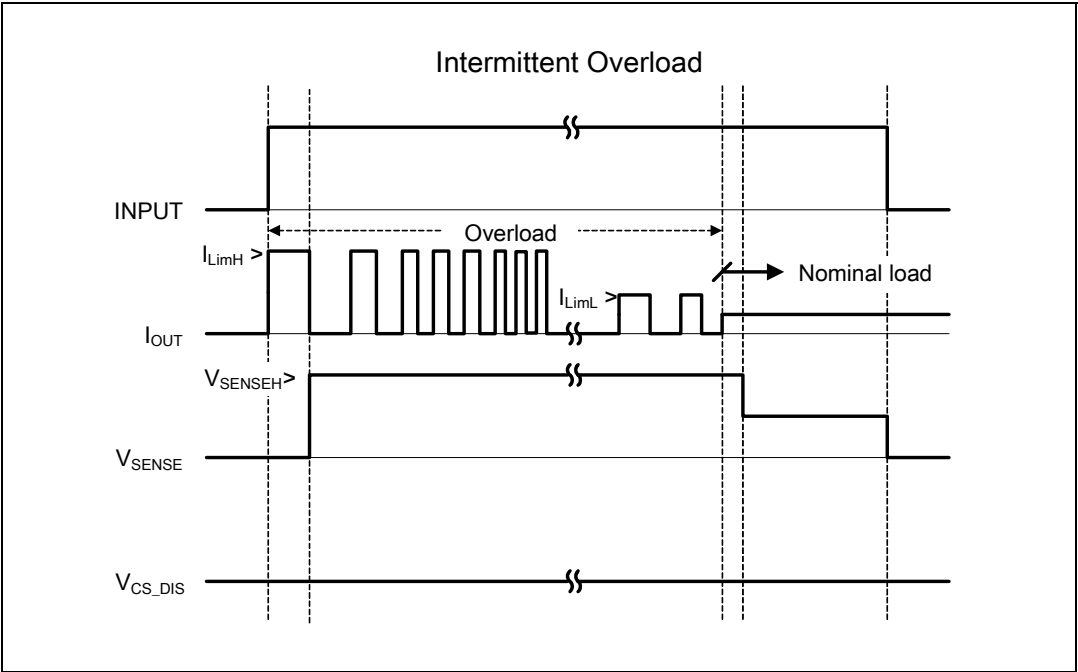


Figure 14. Off-state open load with external circuitry

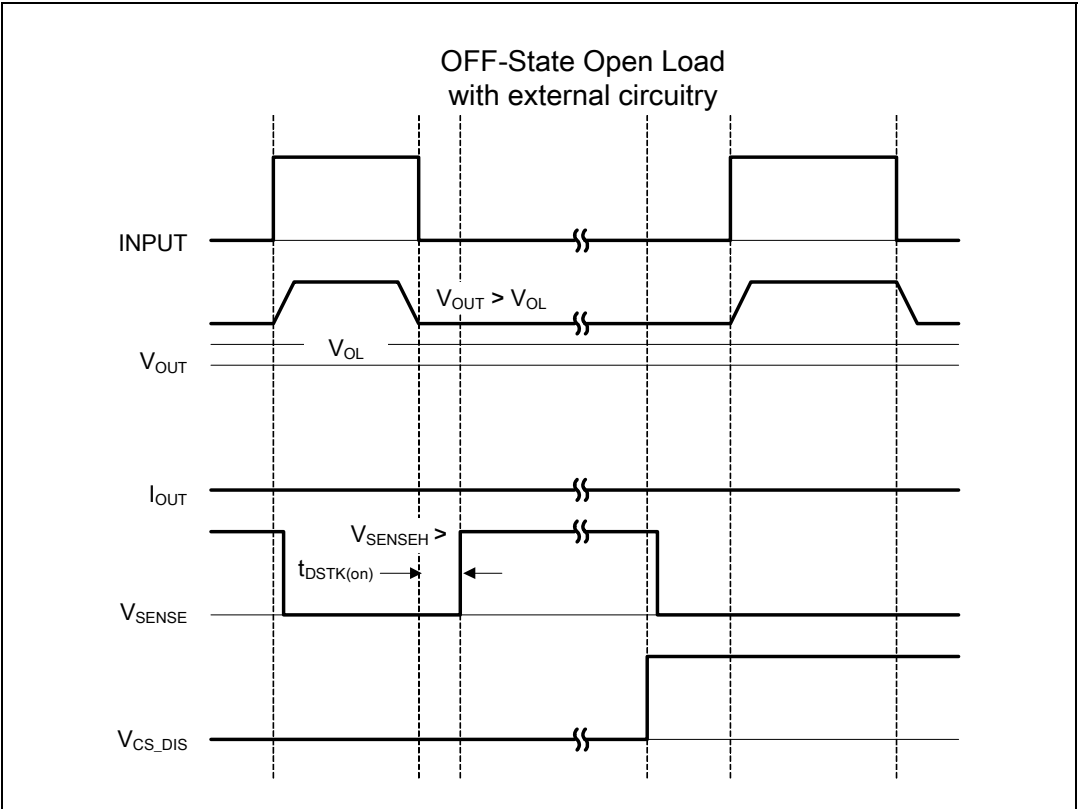


Figure 15. Short to V_{CC}

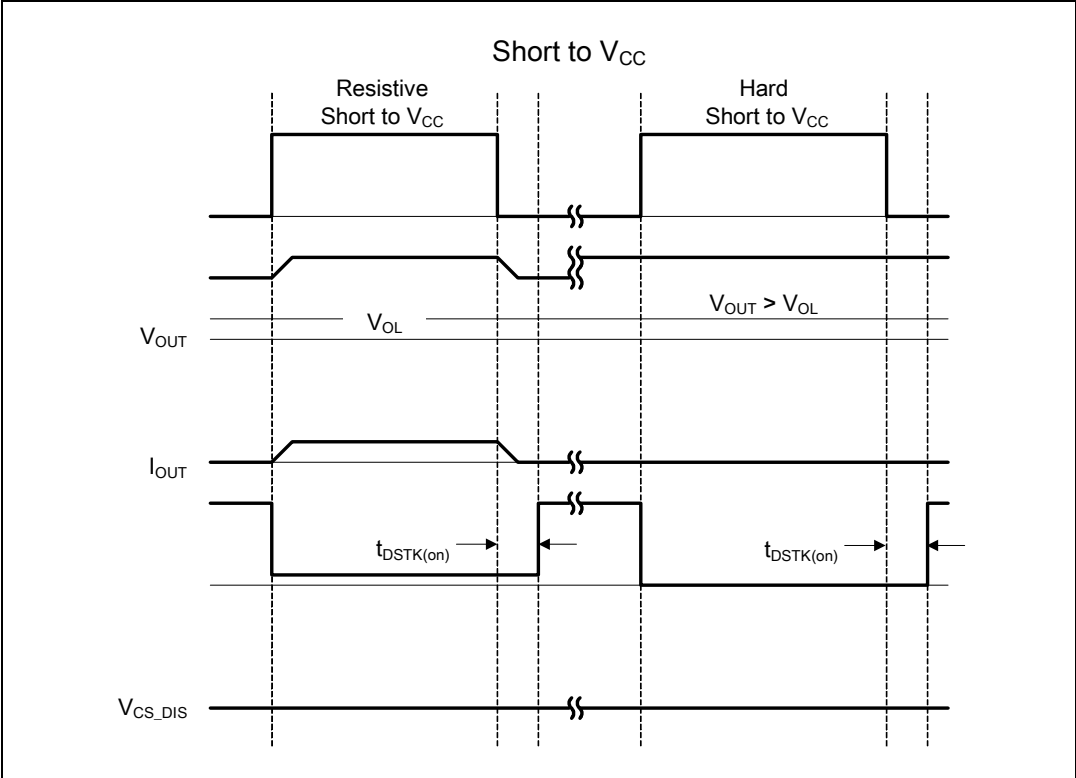
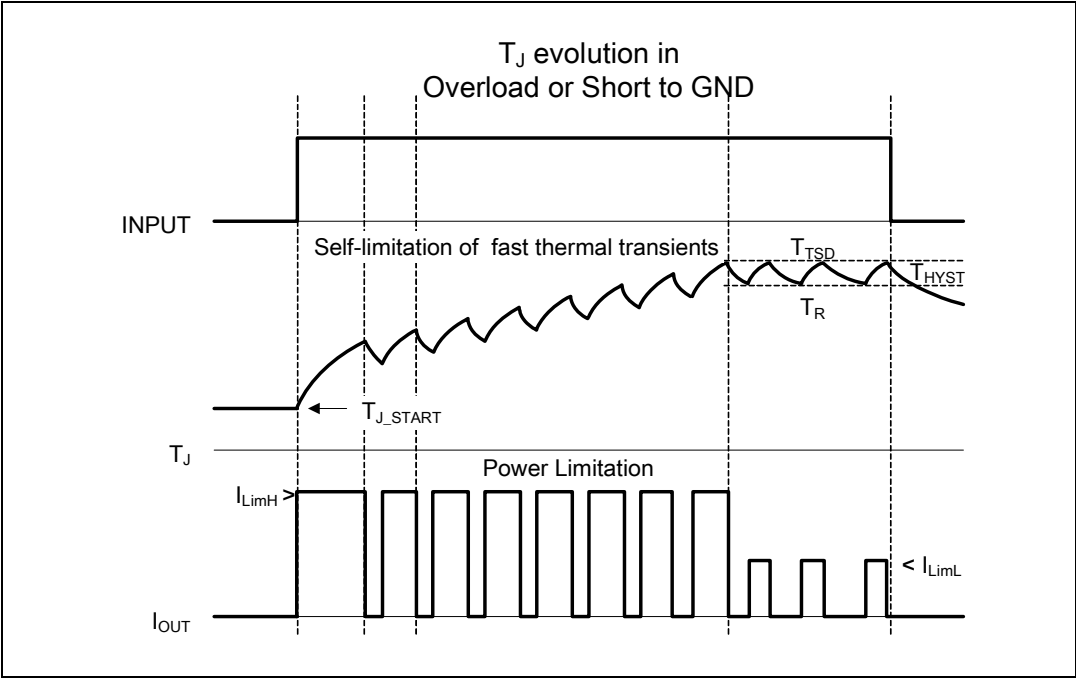


Figure 16. T_J evolution in overload or short to GND



2.5 Electrical characteristics curves

Figure 17. Off-state output current

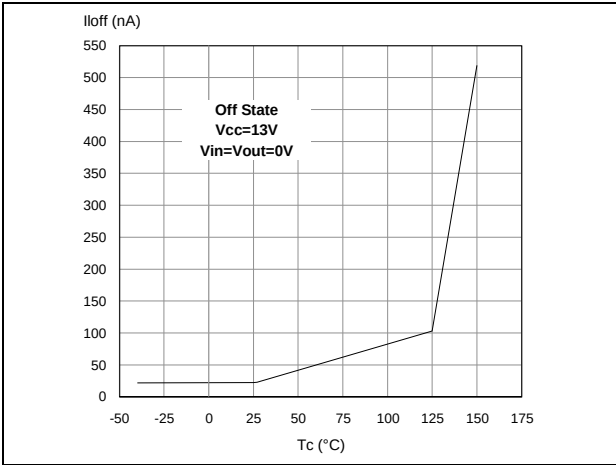


Figure 18. High level input current

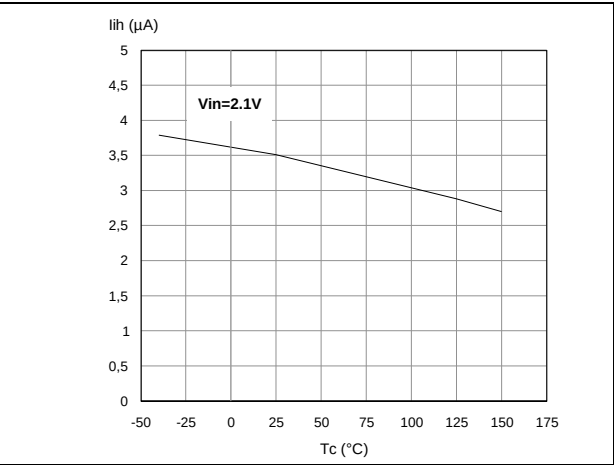


Figure 19. Input clamp voltage

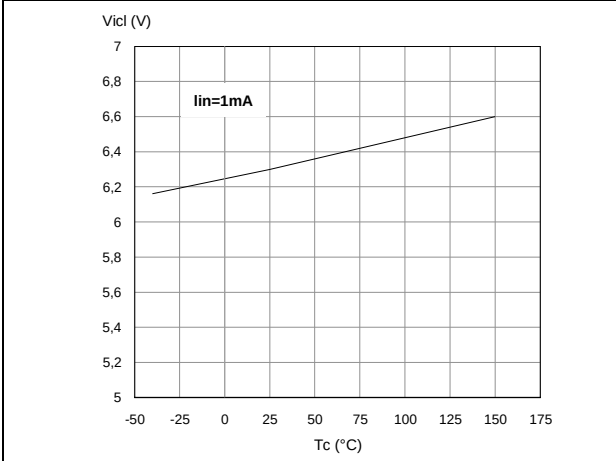


Figure 20. Input low level

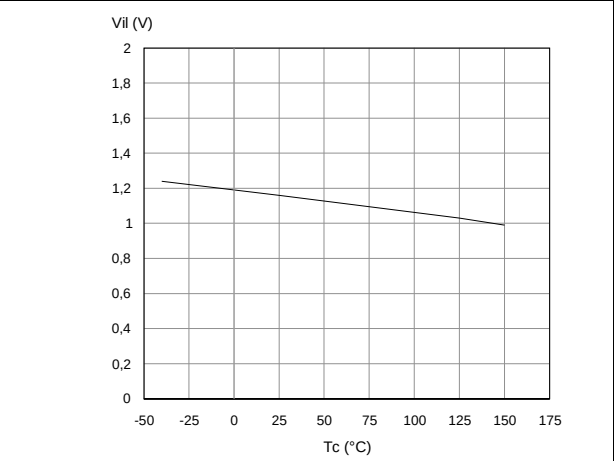


Figure 21. Input high level

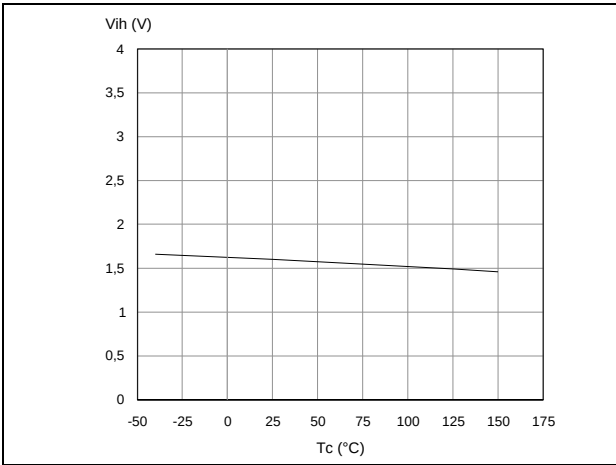


Figure 22. Input hysteresis voltage

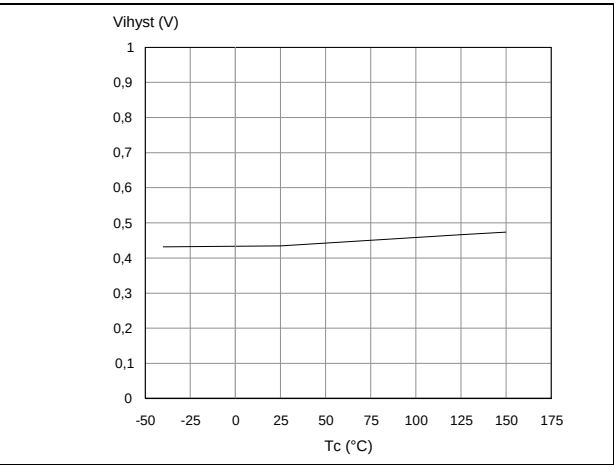


Figure 23. On-state resistance vs T_{case}

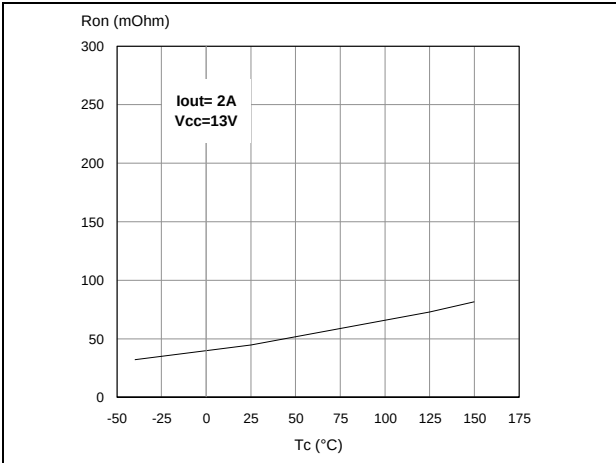


Figure 24. On-state resistance vs V_{CC}

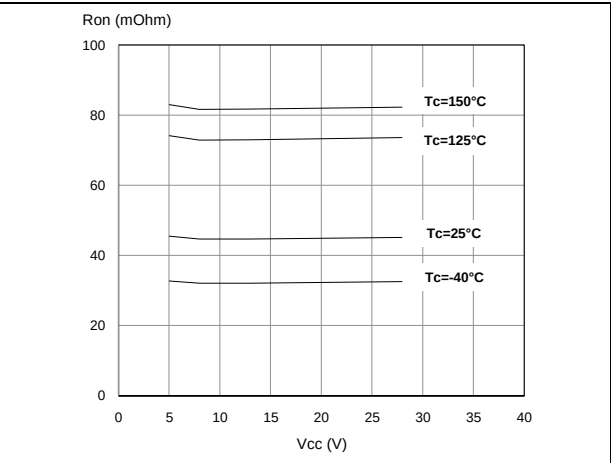


Figure 25. Undervoltage shutdown

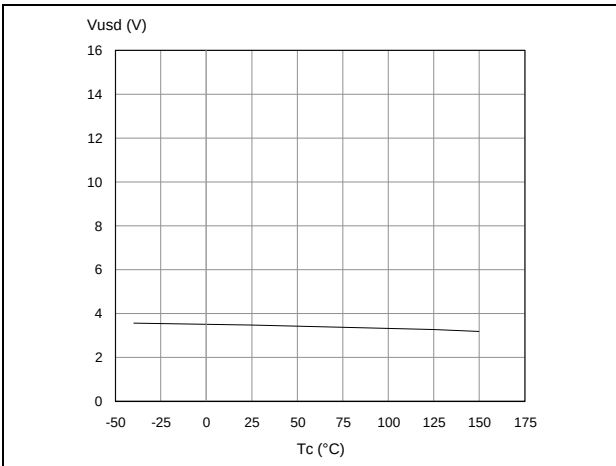


Figure 26. Turn-on voltage slope

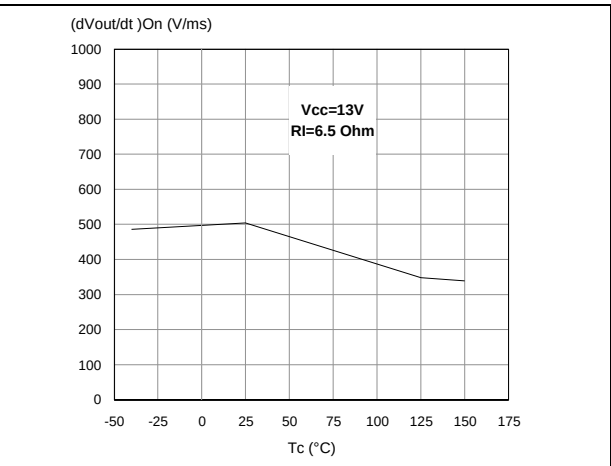


Figure 27. I_{LIMH} vs T_{case}

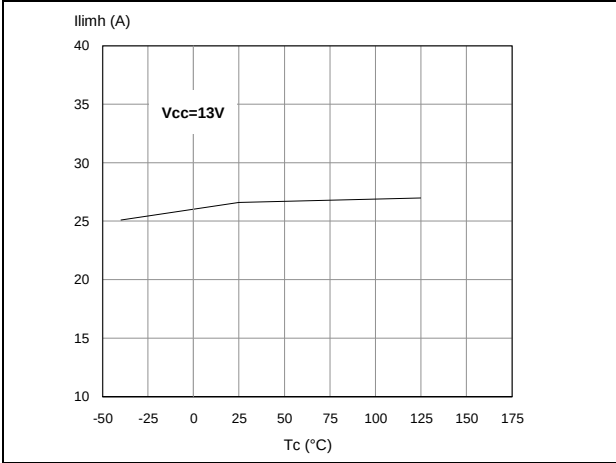


Figure 28. Turn-off voltage slope

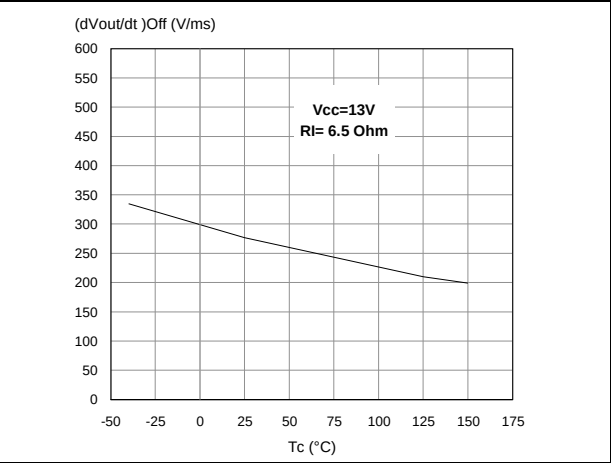


Figure 29. CS_DIS high level voltage

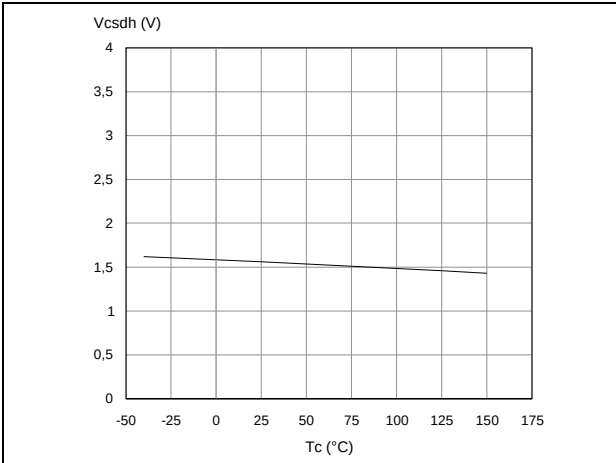


Figure 30. CS_DIS clamp voltage

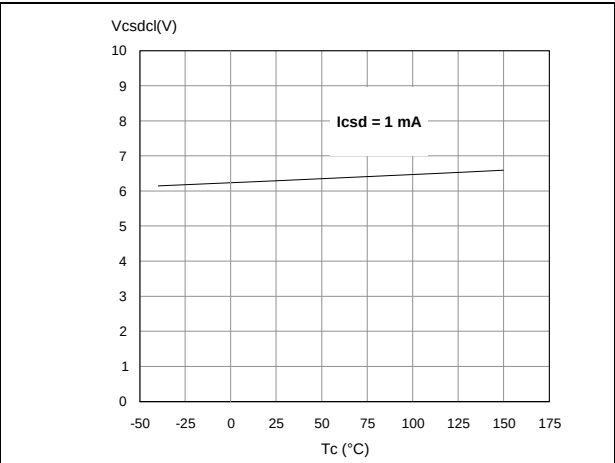
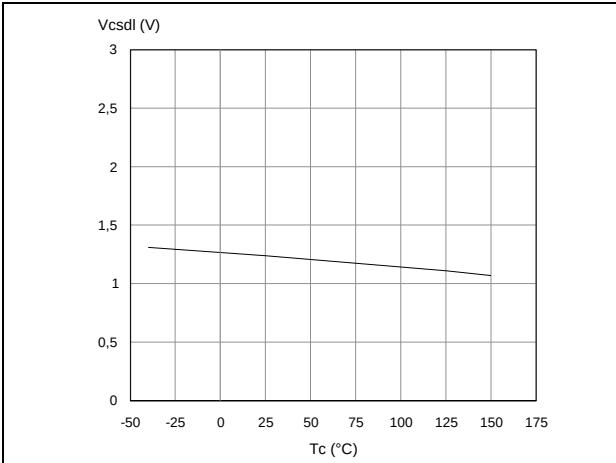


Figure 31. CS_DIS low level voltage



If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then ST suggests to utilize [Section 3.1.2: Solution 2: diode \(D_{GND}\) in the ground line](#).

3.1.2 Solution 2: diode (D_{GND}) in the ground line

A resistor ($R_{GND} = 1\text{ k}\Omega$) should be inserted in parallel to D_{GND} if the device drives an inductive load.

This small signal diode can be safely shared amongst several different HSDs. Also in this case, the presence of the ground network will produce a shift ($\approx 600\text{mV}$) in the input threshold and in the status output values if the microprocessor ground is not common to the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

3.2 Load dump protection

D_{ld} is necessary (voltage transient suppressor) if the load dump peak voltage exceeds the V_{CC} maximum DC rating. The same applies if the device is subject to transients on the V_{CC} line that are greater than the ones shown in the ISO 7637-2: 2004(E) table.

3.3 MCU I/Os protection

If a ground protection network is used and negative transients are present on the V_{CC} line, the control pins are pulled negative.

ST suggests to insert a resistor (R_{prot}) in line to prevent the microcontroller I/O pins from latching-up.

The value of these resistors is a compromise between the leakage current of microcontroller and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of microcontroller I/Os:

$$-V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax}$$

Calculation example:

For $V_{CCpeak} = -100\text{V}$ and $I_{latchup} \geq 20\text{mA}$; $V_{OH\mu C} \geq 4.5\text{V}$

$$5\text{k}\Omega \leq R_{prot} \leq 180\text{k}\Omega$$

Recommended values: $R_{prot} = 10\text{k}\Omega$, $C_{EXT} = 10\text{nF}$.

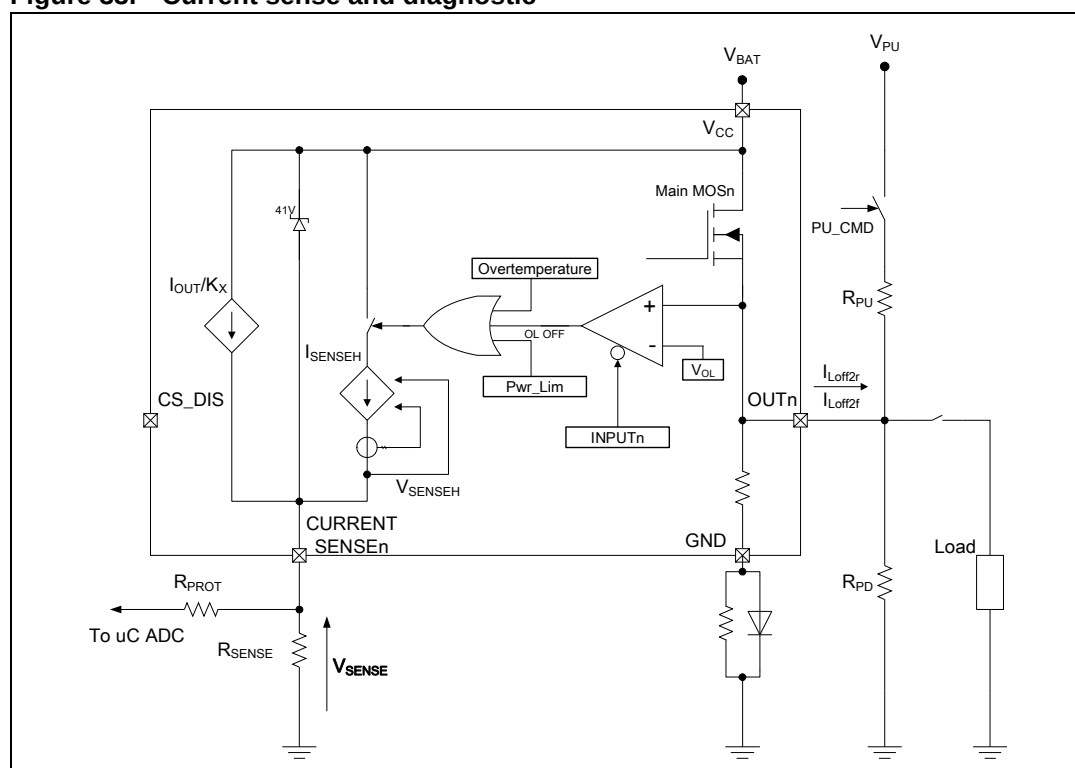
3.4 Current sense and diagnostic

The current sense pin performs a double function (see [Figure 33: Current sense and diagnostic](#)):

- **Current mirror of the load current in normal operation**, delivering a current proportional to the load current according to a known ratio K_X .
The current I_{SENSE} can be easily converted to a voltage V_{SENSE} by means of an external resistor R_{SENSE} . Linearity between I_{OUT} and V_{SENSE} is ensured up to 5V minimum (see parameter V_{SENSE} in [Table 9: Current sense \(8 V < V_{CC} < 18 V\)](#)). The current sense accuracy depends on the output current (refer to current sense electrical

- **Diagnostic flag in fault conditions**, delivering a fixed voltage V_{SENSEH} up to a maximum current I_{SENSEH} in case of the following fault conditions (refer to [Table 11: Truth table](#)):
 - Power limitation activation
 - Overtemperature
 - Short to V_{CC} in off-state
 - Open-load in off-state with additional external components.

Figure 33. Current sense and diagnostic



Short to V_{CC}

Off-state open-load with external circuitry

Detection of an open-load in off mode requires an external pull-up resistor (R_{PU}) connecting the output to a positive supply voltage (V_{PU}).

It is preferable that V_{PU} is switched off during the module standby mode to avoid an increase in overall standby current consumption in normal conditions, that is, when the load is connected.

An external pull-down resistor (R_{PD}) connected between output and GND is mandatory to avoid misdetection in case of floating outputs in off-state (see [Figure 33: Current sense and diagnostic](#)).

R_{PD} must be selected in order to ensure $V_{OUT} < V_{OLmin}$ unless pulled up by the external circuitry:

$$V_{OUT}|_{Pull-up_OFF} = R_{PD} \cdot I_{L(off2)f} < V_{OLmin} = 2V$$

$R_{PD} \leq 22\text{ K}\Omega$ is recommended.

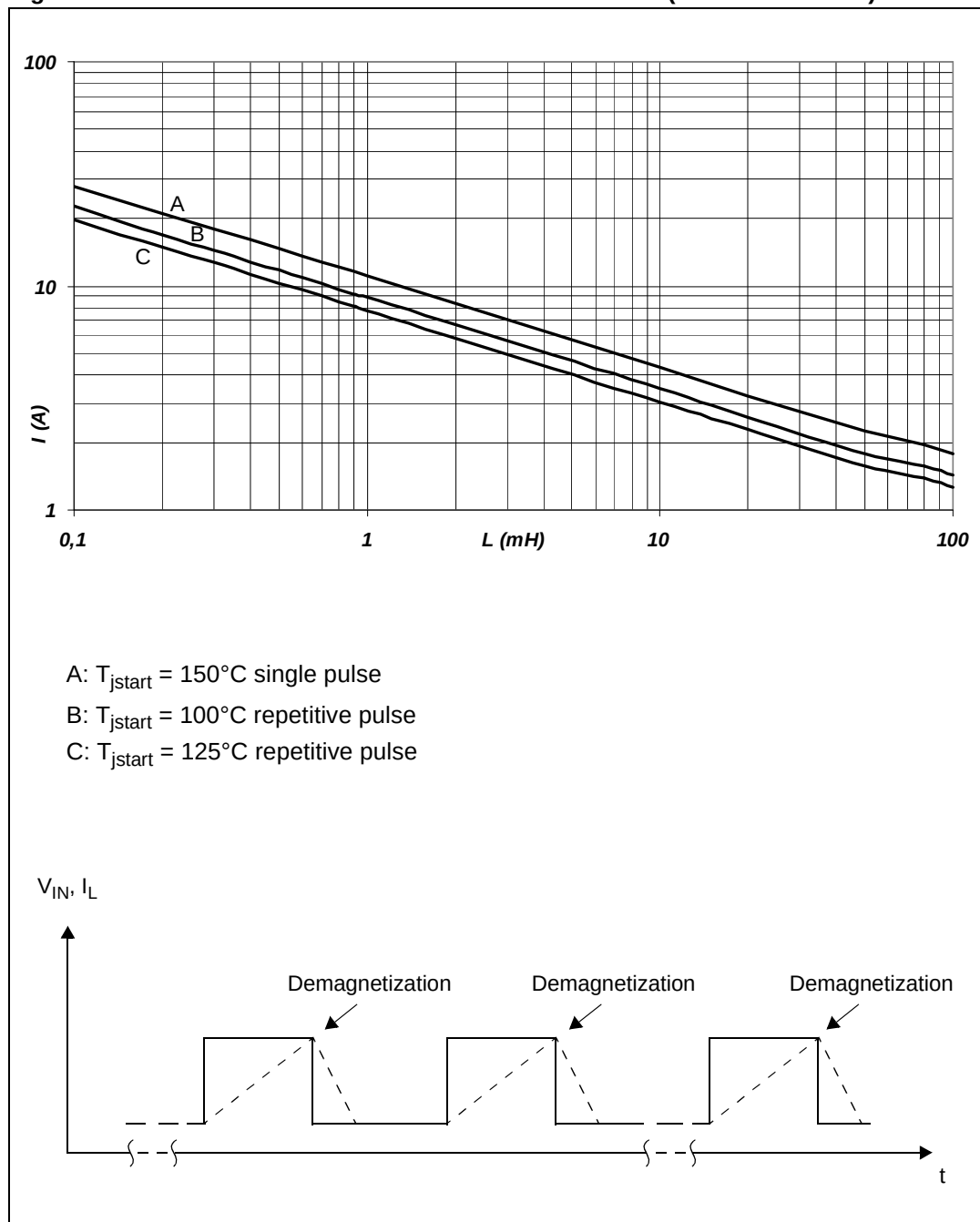
For proper open load detection in off-state, the external pull-up resistor must be selected according to the following formula:

$$V_{OUT}|_{Pull-up_ON} = \frac{R_{PD} \cdot V_{PU} - R_{PU} \cdot R_{PD} \cdot I_{L(off2)r}}{R_{PU} + R_{PD}} > V_{OLmax} = 4V$$

For the values of V_{OLmin} , V_{OLmax} , $I_{L(off2)r}$ and $I_{L(off2)f}$ see [Table 10: Open load detection \(\$8V < V_{CC} < 18V\$ \)](#).

3.5 Maximum demagnetization energy ($V_{CC} = 13.5V$)

Figure 34. Maximum turn-off current versus inductance (for each channel)



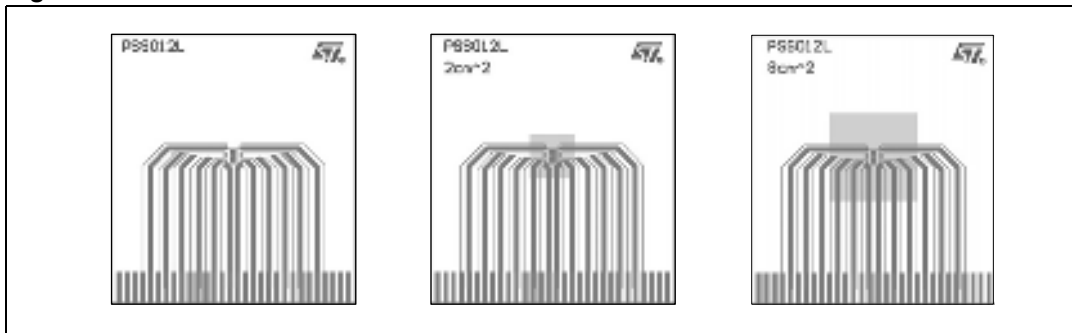
Note:

Values are generated with $R_L = 0 \Omega$. In case of repetitive pulses, T_{jstart} (at the beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B.

4 Package and PCB thermal data

4.1 PowerSSO-12 thermal data

Figure 35. PowerSSO-12 PC board



Note:

Layout condition of R_{th} and Z_{th} measurements (PCB: double layer, thermal vias, FR4 area= 77mm x 86mm, PCB thickness=1.6mm, Cu thickness=70 μ m (front and back side), copper areas: from minimum pad lay-out to 8cm²).

Figure 36. $R_{thj-amb}$ Vs. PCB copper area in open box free air condition (one channel ON)

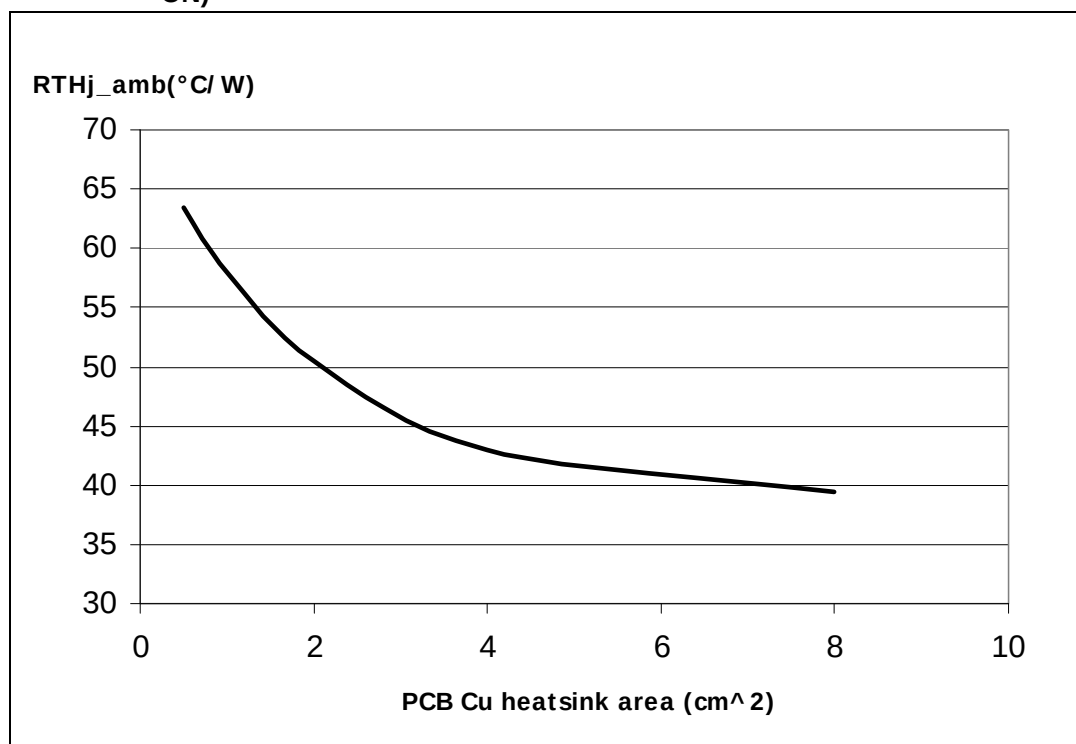
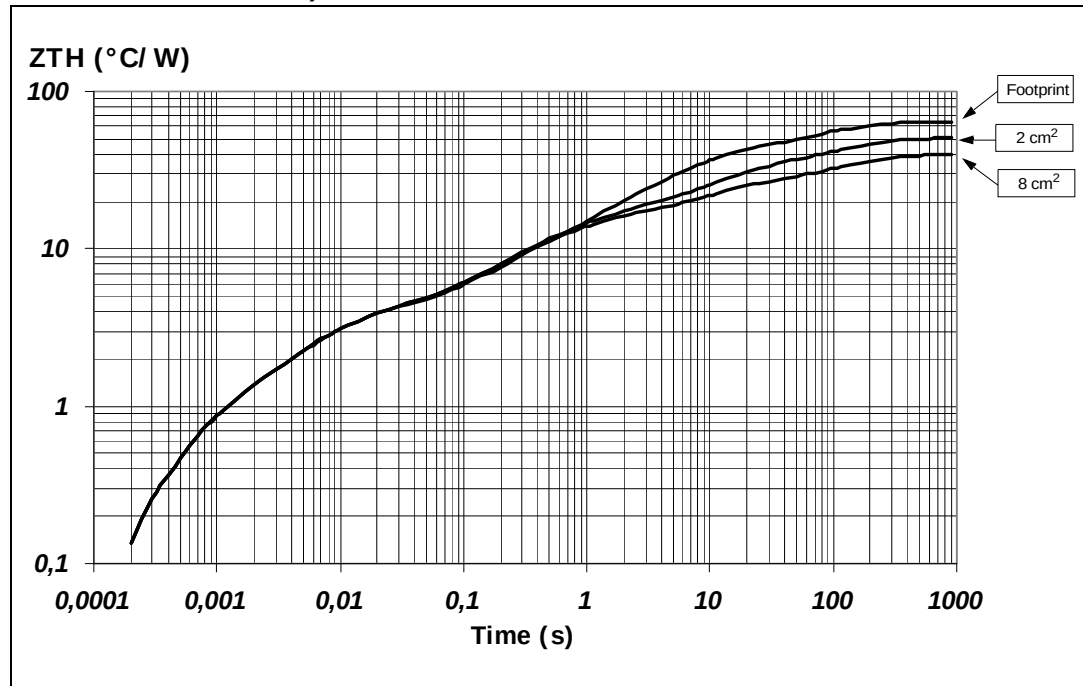


Figure 37. PowerSSO-12 thermal impedance junction ambient single pulse (one channel ON)

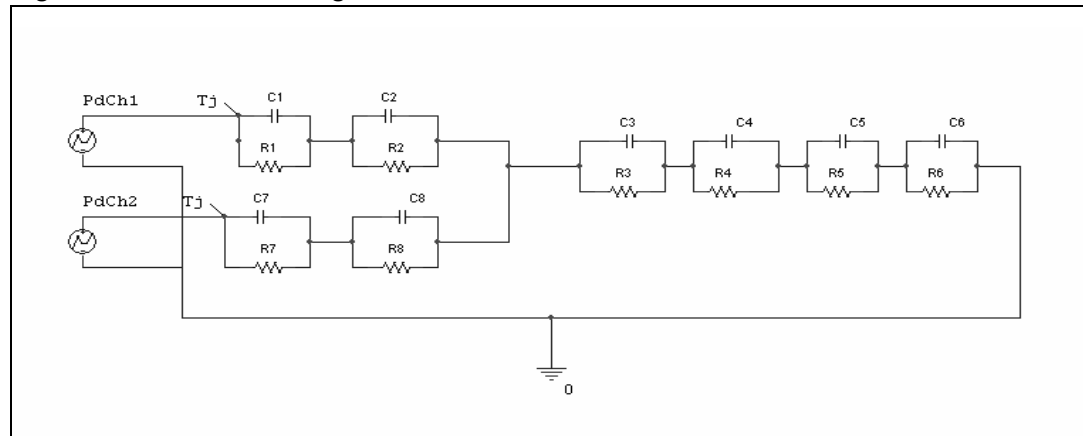


Equation 1: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

$$\text{where } \delta = t_p / T$$

Figure 38. Thermal fitting model of a double channel HSD in PowerSSO-12



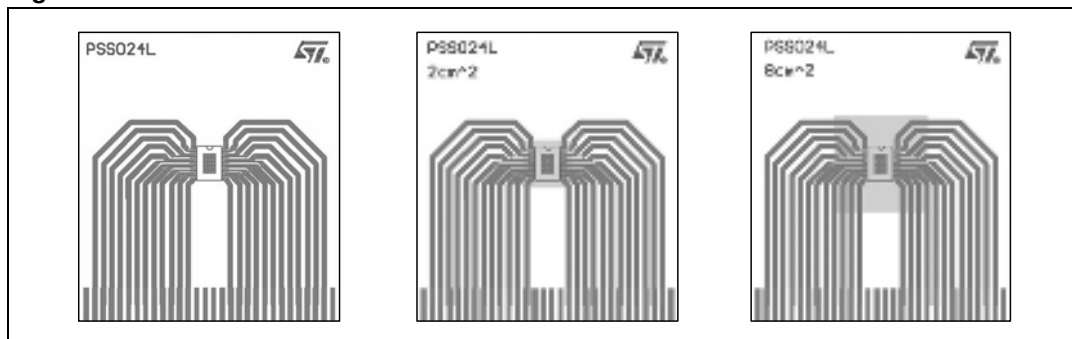
1. The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered.

Table 15. Thermal parameters

Area/island (cm ²)	Footprint	2	8
R1=R7 (°C/W)	0.7		
R2=R8 (°C/W)	2.8		
R3 (°C/W)	4		
R4 (°C/W)	8	8	7
R5 (°C/W)	22	15	10
R6 (°C/W)	26	20	15
C1=C7 (W.s/°C)	0.001		
C2=C8 (W.s/°C)	0.0025		
C3 (W.s/°C)	0.05		
C4 (W.s/°C)	0.2	0.1	0.1
C5 (W.s/°C)	0.27	0.8	1
C6 (W.s/°C)	3	6	9

4.2 PowerSSO-24 thermal data

Figure 39. PowerSSO-24 PC board



Note: Layout condition of R_{th} and Z_{th} measurements (PCB: double layer, thermal vias, FR4 area= 77mm x 86mm, PCB thickness=1.6mm, Cu thickness=70μm (front and back side), copper areas: from minimum pad lay-out to 8cm²).

Figure 40. $R_{thj-amb}$ vs PCB copper area in open box free air condition (one channel ON)

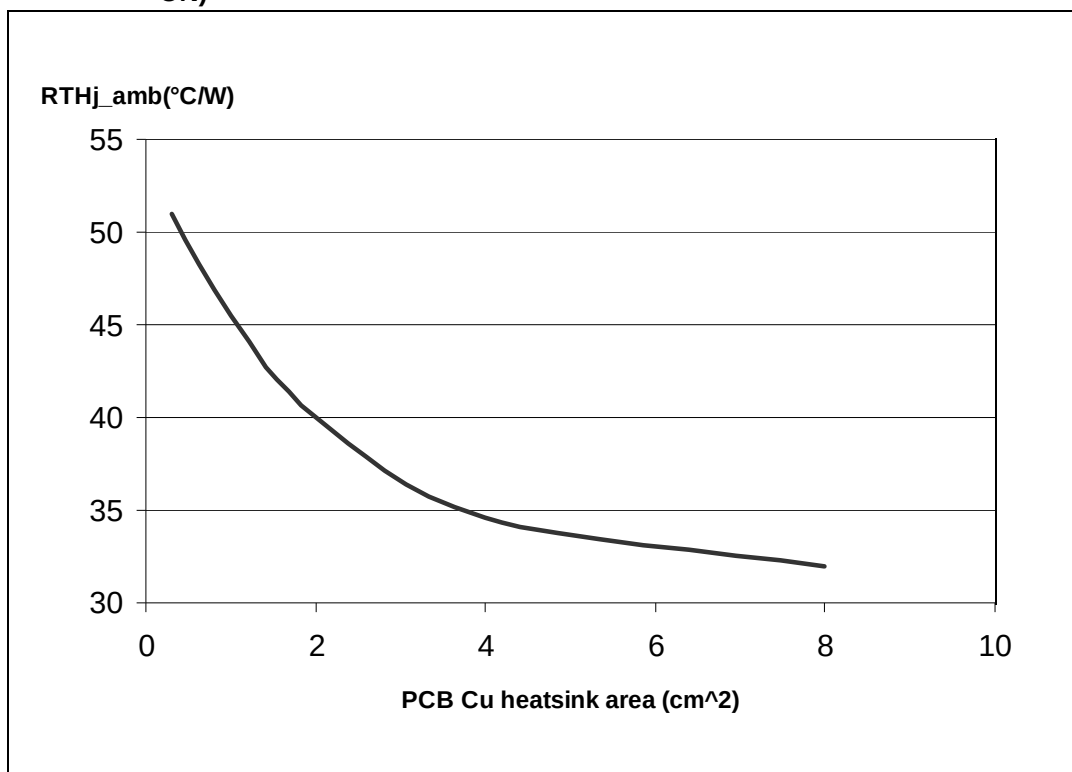
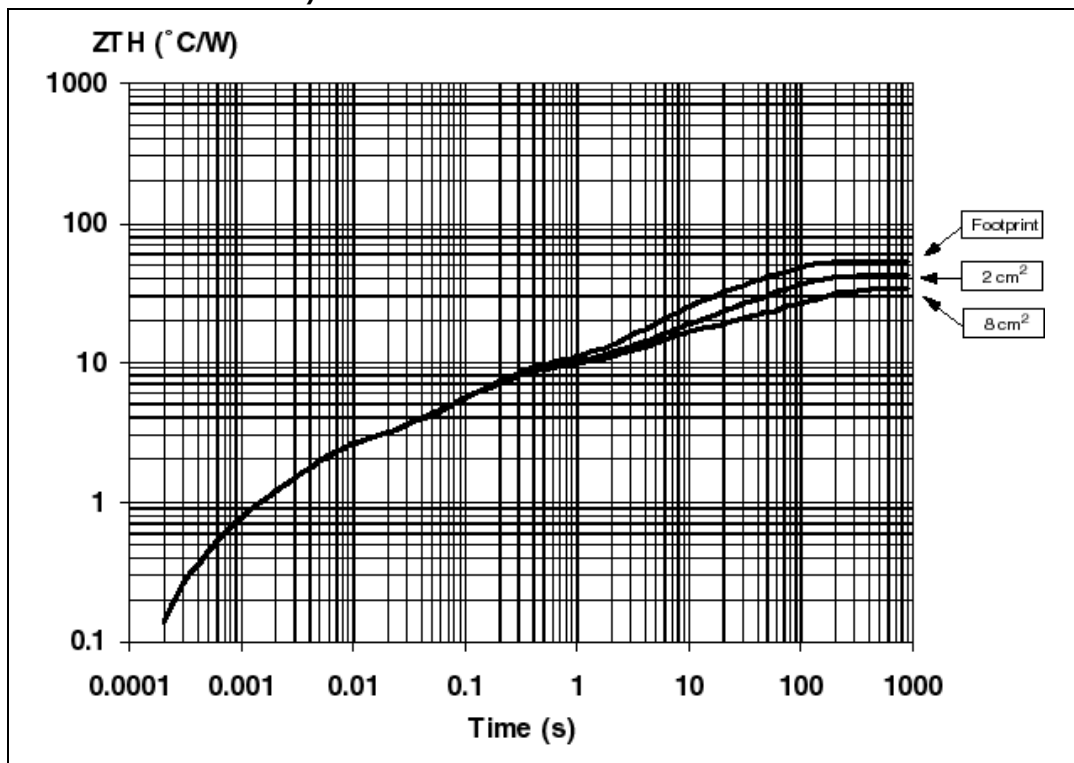


Figure 41. PowerSSO-24 thermal impedance junction ambient single pulse (one channel ON)

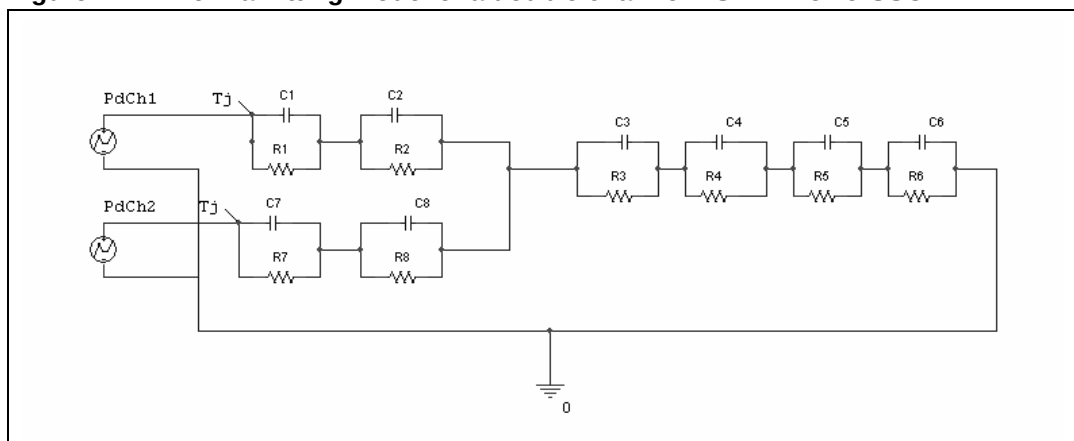


Equation 2: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

$$\text{where } \delta = t_p / T$$

Figure 42. Thermal fitting model of a double channel HSD in PowerSSO-24



1. The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered.

Table 16. Thermal parameters

Area / island (cm ²)	Footprint	2	8
R1 = R7 (°C/W)	0.4		
R2 = R8 (°C/W)	2		
R3 (°C/W)	6		
R4 (°C/W)	7.7		
R5 (°C/W)	9	9	8
R6 (°C/W)	28	17	10
C1 = C7 (W.s/°C)	0.001		
C2 = C8 (W.s/°C)	0.0022		
C3 (W.s/°C)	0.025		
C4 (W.s/°C)	0.75		
C5 (W.s/°C)	1	4	9
C6 (W.s/°C)	2.2	5	17

5 Package and packing information

5.1 ECOPACK®

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.

ECOPACK® is an ST trademark.

5.2 PowerSSO-12 package information

Figure 43. PowerSSO-12 package dimensions

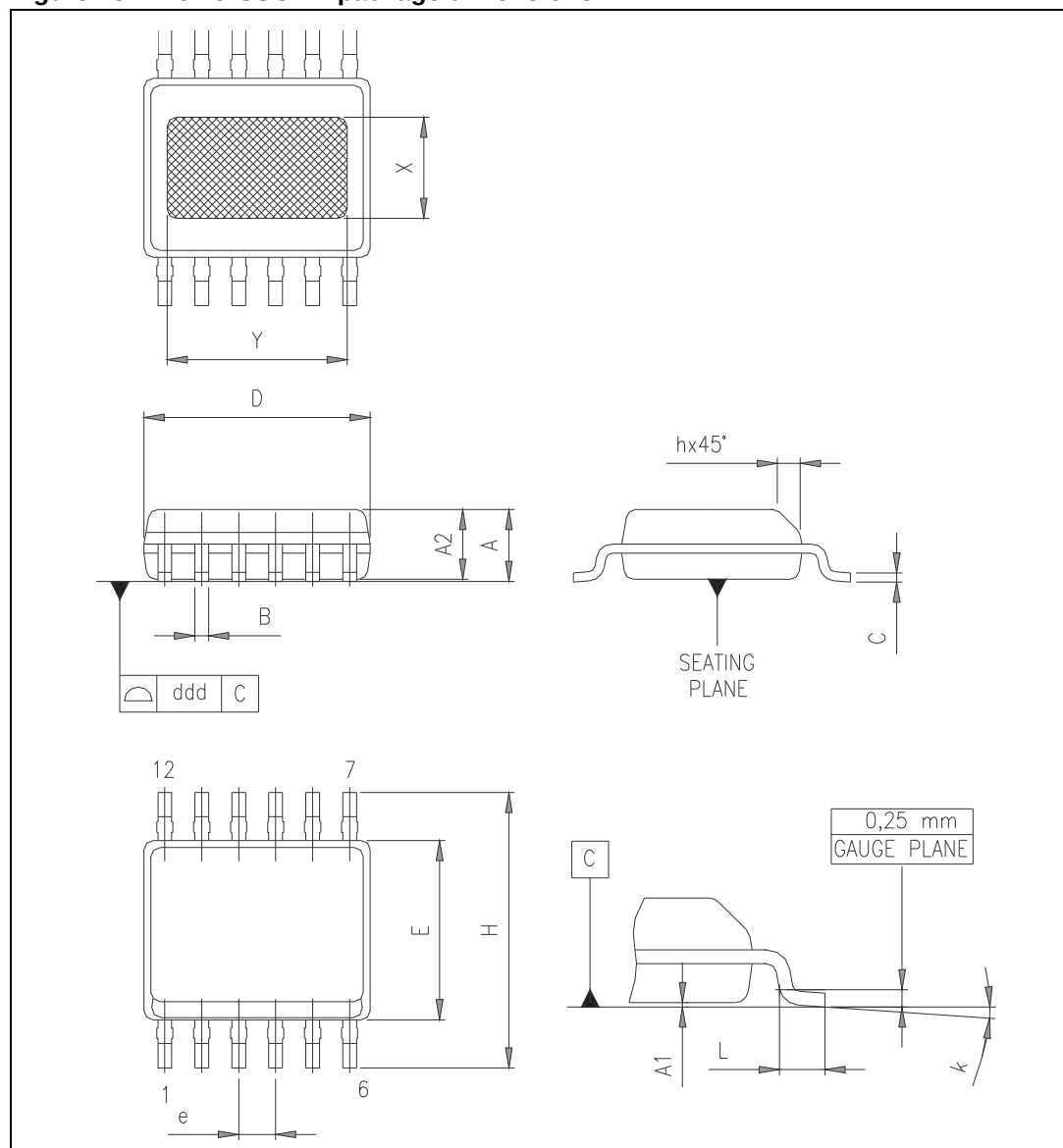


Table 17. PowerSSO-12 mechanical data

Symbol	Millimeters		
	Min.	Typ.	Max.
A	1.25		1.62
A1	0		0.1
A2	1.10		1.65
B	0.23		0.41
C	0.19		0.25
D	4.8		5.0
E	3.8		4.0
e		0.8	
H	5.8		6.2
h	0.25		0.5
L	0.4		1.27
k	0°		8°
X	1.9		2.5
Y	3.6		4.2
ddd			0.1

5.3 PowerSSO-24 package information

Figure 44. PowerSSO-24 package dimensions

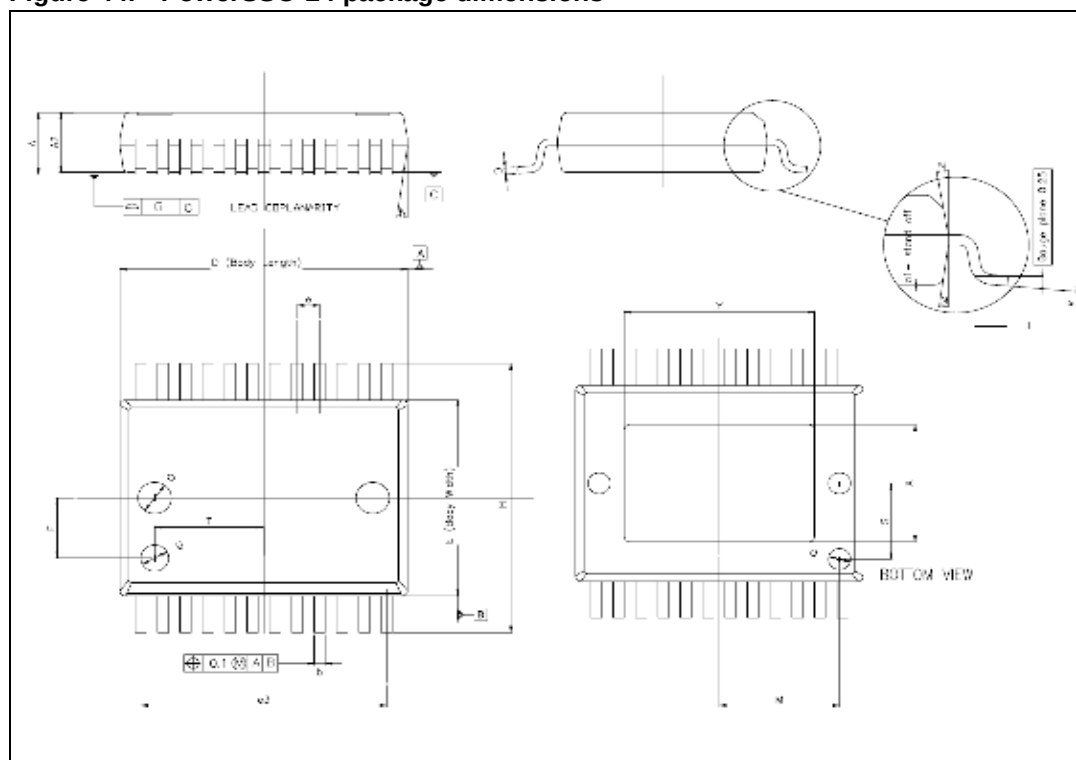


Table 18. PowerSSO-24 mechanical data^{(1) (2)}

Symbol	Millimeters		
	Min.	Typ.	Max.
A			2.45
A2	2.15		2.35
a1	0		0.1
b	0.33		0.51
c	0.23		0.32
D ⁽³⁾	10.10		10.50
E ⁽³⁾	7.40		7.60
e		0.8	
e3		8.8	
F		2.3	
G			0.1
H	10.1		10.5
h			0.4
k	0°		8°
L	0.55		0.85
O		1.2	
Q		0.8	
S		2.9	
T		3.65	
U		1.0	
N			10°
X	4.1		4.7
Y	6.5		7.1

1. No intrusion allowed inwards the leads.
2. Flash or bleeds on exposed die pad shall not exceed 0.5 mm per side
3. "D and E" do not include mold Flash or protrusions. Mold Flash or protrusions shall not exceed 0.15 mm per side

5.4 PowerSSO-12 packing information

Figure 45. PowerSSO-12 tube shipment (no suffix)

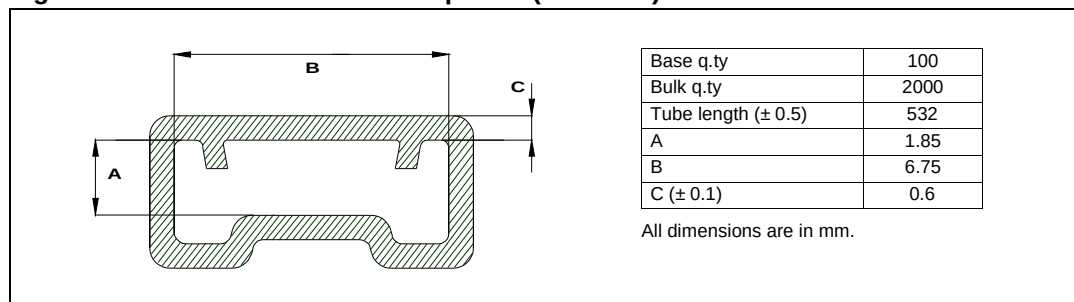
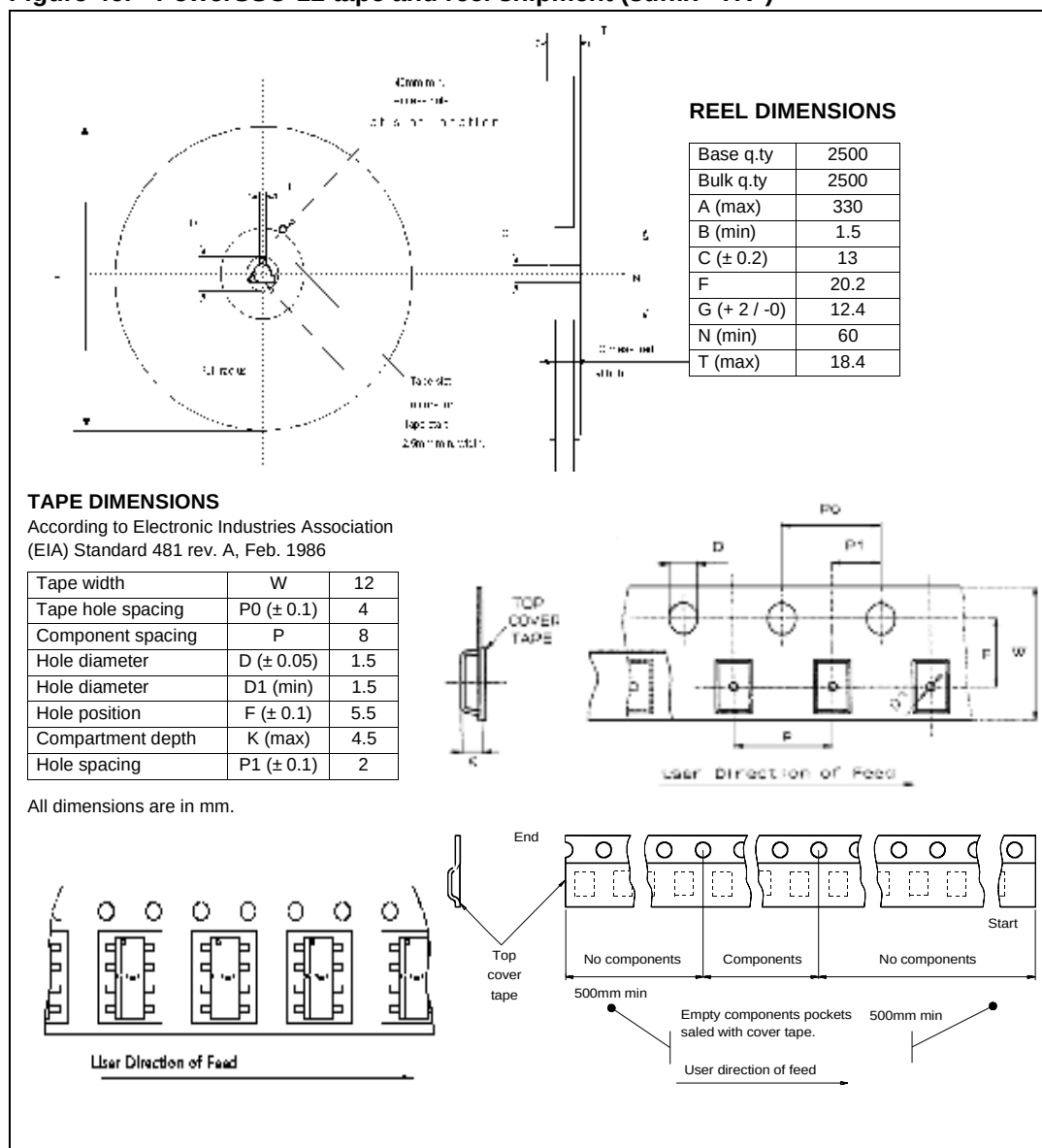


Figure 46. PowerSSO-12 tape and reel shipment (suffix "TR")



5.5 PowerSSO-24 packing information

Figure 47. PowerSSO-24 tube shipment (no suffix)

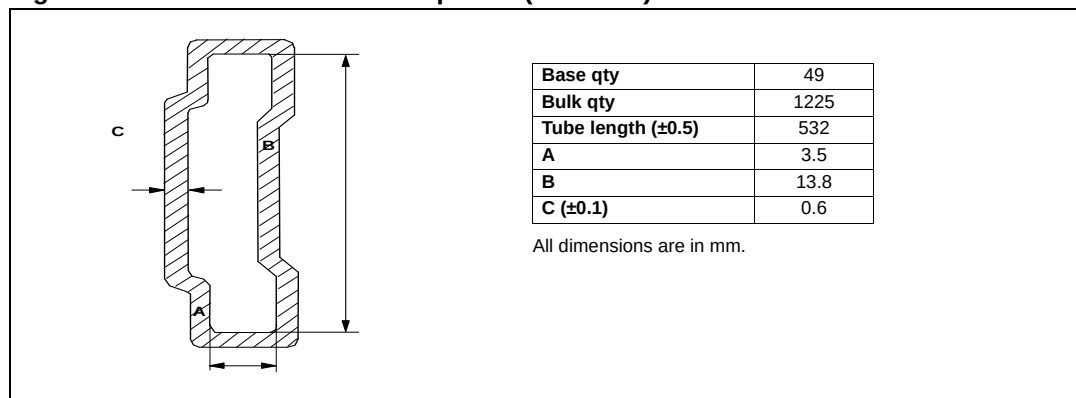
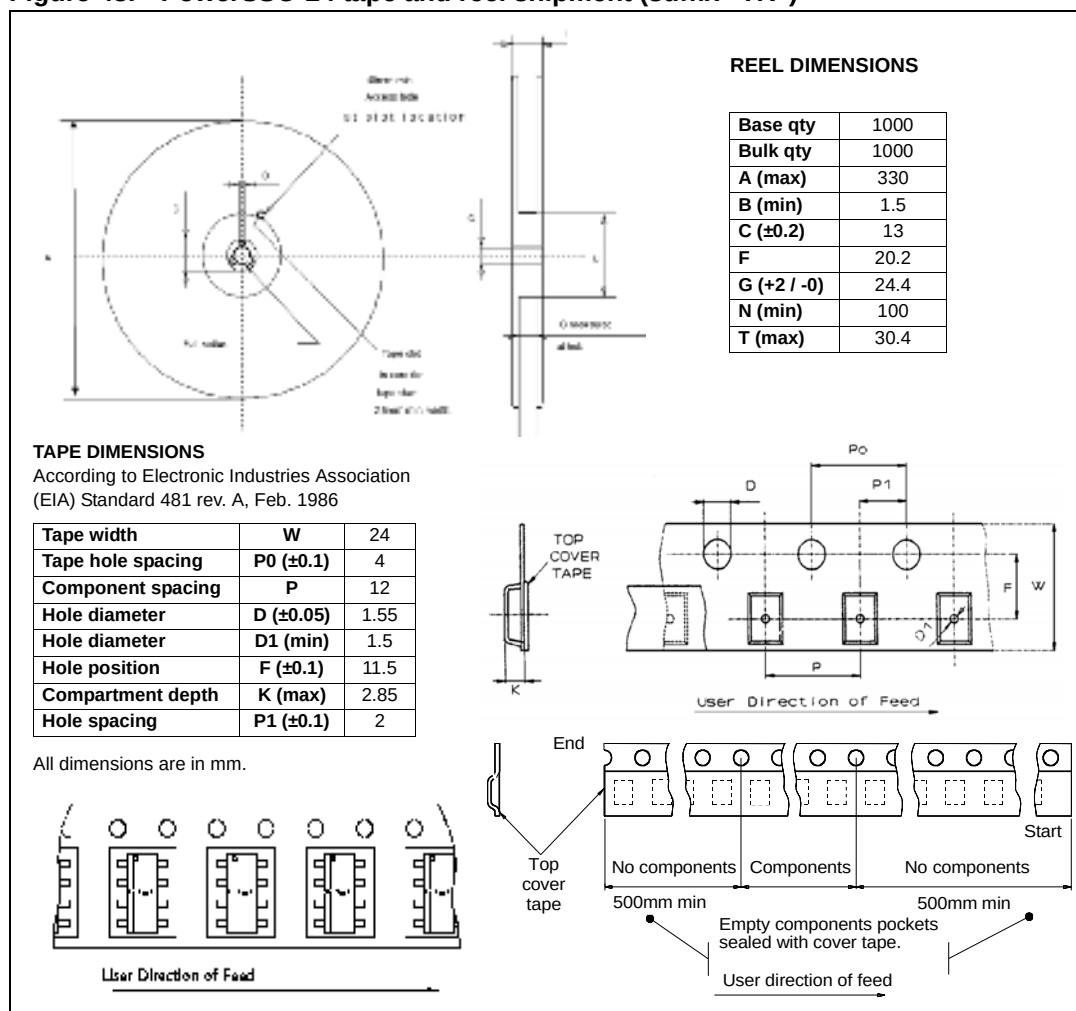


Figure 48. PowerSSO-24 tape and reel shipment (suffix "TR")



6 Order codes

Table 19. Device summary

Package	Order codes	
	Tube	Tape and reel
PowerSSO-12	VND5E050ACJ-E	VND5E050ACJTR-E
PowerSSO-24	VND5E050ACK-E	VND5E050ACKTR-E

7 Revision history

Table 20. Document revision history

Date	Revision	Changes
18-Nov-2011	1	Initial release.
18-Sep-2013	2	Updated disclaimer.

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